

**L & S BAND GaAs FET [ Plastic Mold Lead-less PKG ]****DESCRIPTION**

The MGF0952P GaAs FET with an N-channel schottky Gate, is designed for use L/S band amplifiers.

**FEATURES**

- High output power  
Po=36.5dBm(TYP.) @f=2.15GHz, Pin=25dBm
- High power gain  
Glp=13.5dB(TYP.) @f=2.15GHz
- High power added efficiency  
 $\eta_{add}$ =50%(TYP.) @f=2.15GHz, Pin=25dBm
- Plastic Mold Lead-less PKG

**APPLICATION**

- For L/S Band power amplifiers

**QUALITY**

- GG

**RECOMMENDED BIAS CONDITIONS**

- Vds=10V    • Ids=700mA    • Rg=100Ω

**Delivery**    Tape & Reel(1.5K)

**Absolute maximum ratings** (Ta=25°C)

| Symbol | Parameter                        | Ratings     | Unit |
|--------|----------------------------------|-------------|------|
| VGSO   | Gate to source breakdown voltage | -15         | V    |
| VGDO   | Gate to drain breakdown voltage  | -15         | V    |
| ID     | Drain current                    | 3.5         | A    |
| IGR    | Reverse gate current             | -10         | mA   |
| IGF    | Forward gate current             | 21          | mA   |
| PT     | Total power dissipation          | 20.0        | W    |
| Tch    | Channel temperature              | 150         | °C   |
| Tstg   | Storage temperature              | -40 to +150 | °C   |

**Recommended maximum ratings** (Ta=25°C)

| Symbol | Parameter           | Ratings | Unit |
|--------|---------------------|---------|------|
| Tch    | Channel temperature | 150     | °C   |

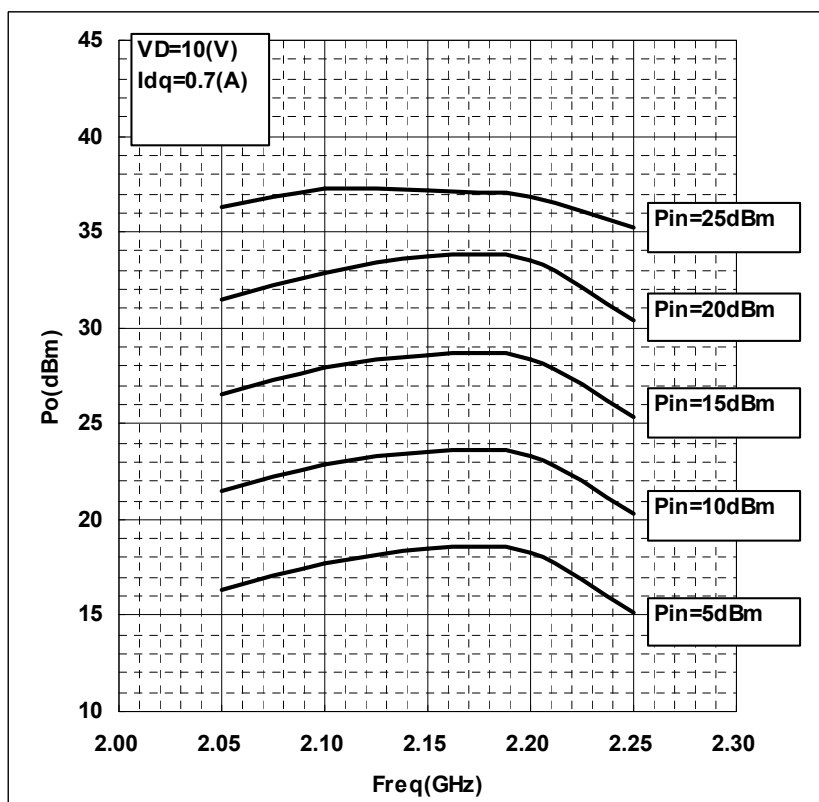
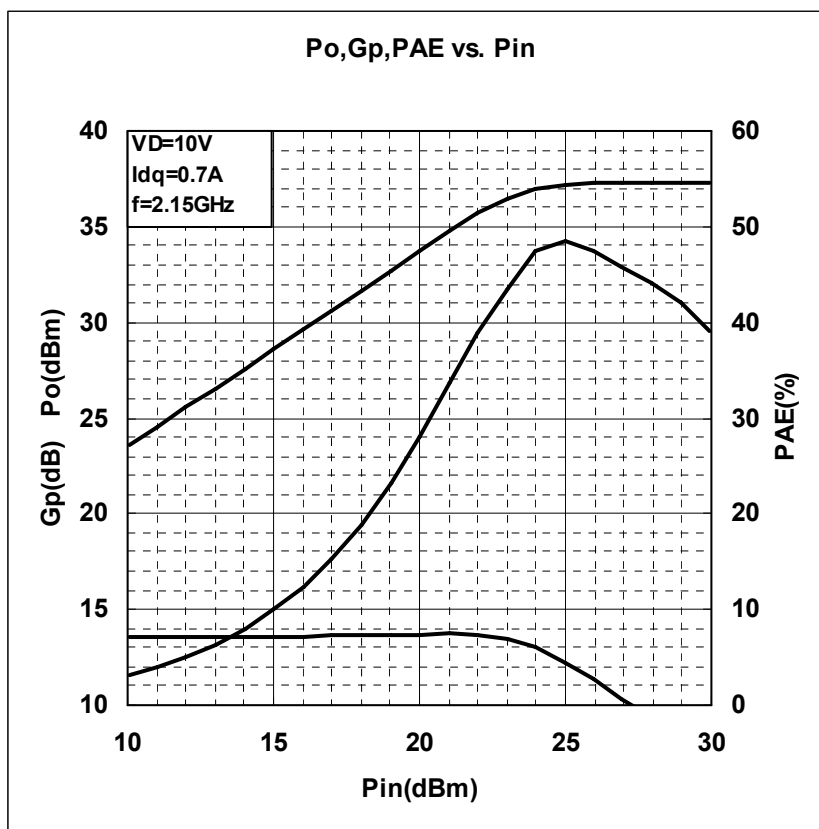
**Electrical characteristics** (Ta=25°C)

| Symbol          | Parameter                                   | Test conditions              | Limits |      |      | Unit |
|-----------------|---------------------------------------------|------------------------------|--------|------|------|------|
|                 |                                             |                              | Min.   | Typ. | Max. |      |
| VGS(off)        | Gate to source cut-off voltage              | VDS=3V, ID=12.6mA            | -1     | -3   | -5   | V    |
| Po *1           | Output power                                | VDS=10V, ID=700mA, f=2.15GHz | 35.0   | 36.5 | --   | dBm  |
| $\eta_{add}$ *1 | Power added Efficiency                      | *1: Pin=25dBm, *2: Pin=15dBm | --     | 50   | --   | %    |
| GLP *2          | Linear Power Gain                           | *3: f1=2.15GHz, f2=2.16GHz   | 11     | 13.5 | --   | dB   |
| IM3 *3          | 3 <sup>rd</sup> order Modulation Distortion | Po(SCL)=25dBm                | --     | -42  | --   | dBc  |
| Rth(ch-c)       | Thermal Resistance *1                       | $\Delta V_f$ Method          | --     | 4.5  | 6.5  | °C/W |

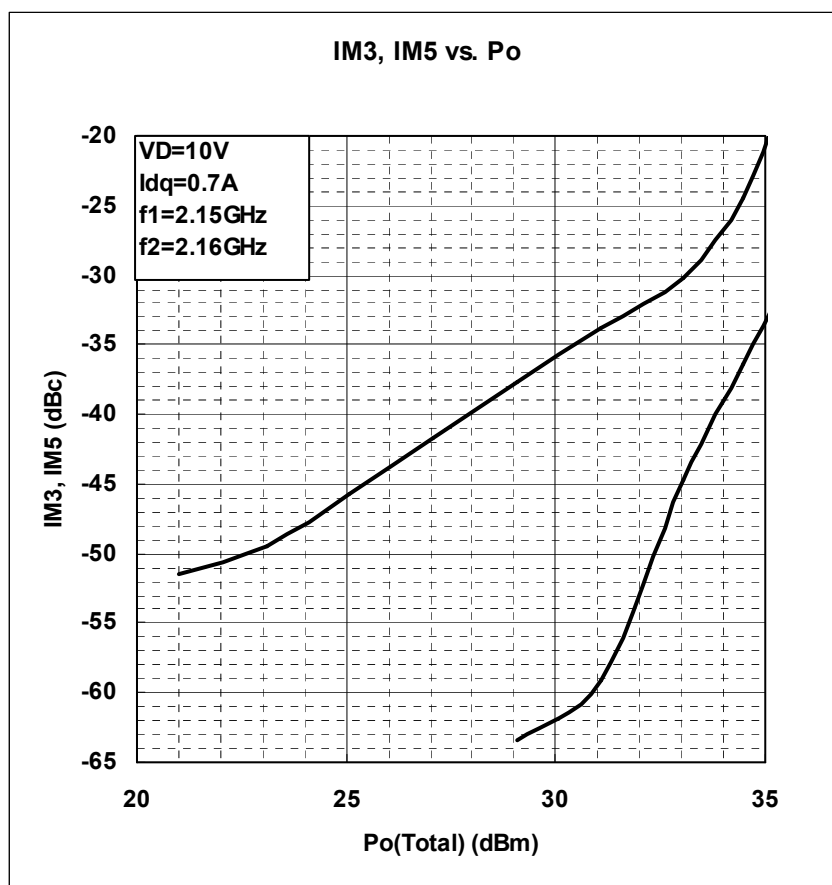
\*1: Channel to case /    Above parameters, ratings, limits are subject to change.

**Fig.1**

# MGF0952P TYPICAL CHARACTERISTICS

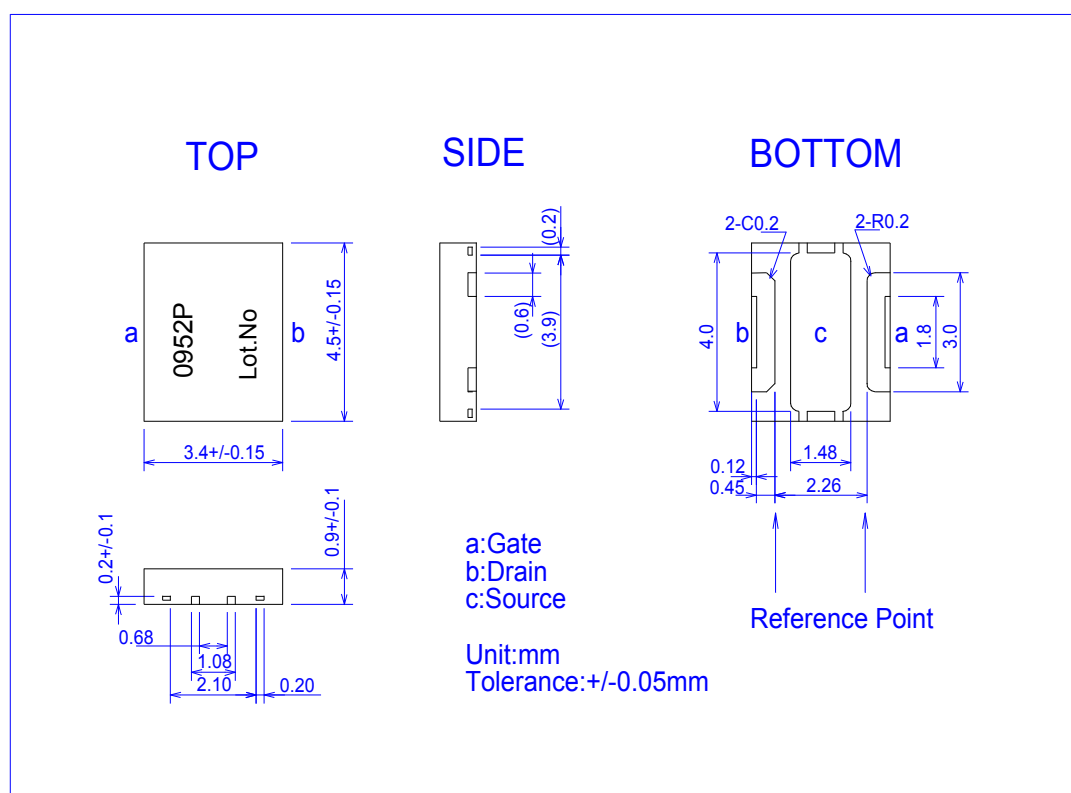


## MGF0952P TYPICAL CHARACTERISTICS



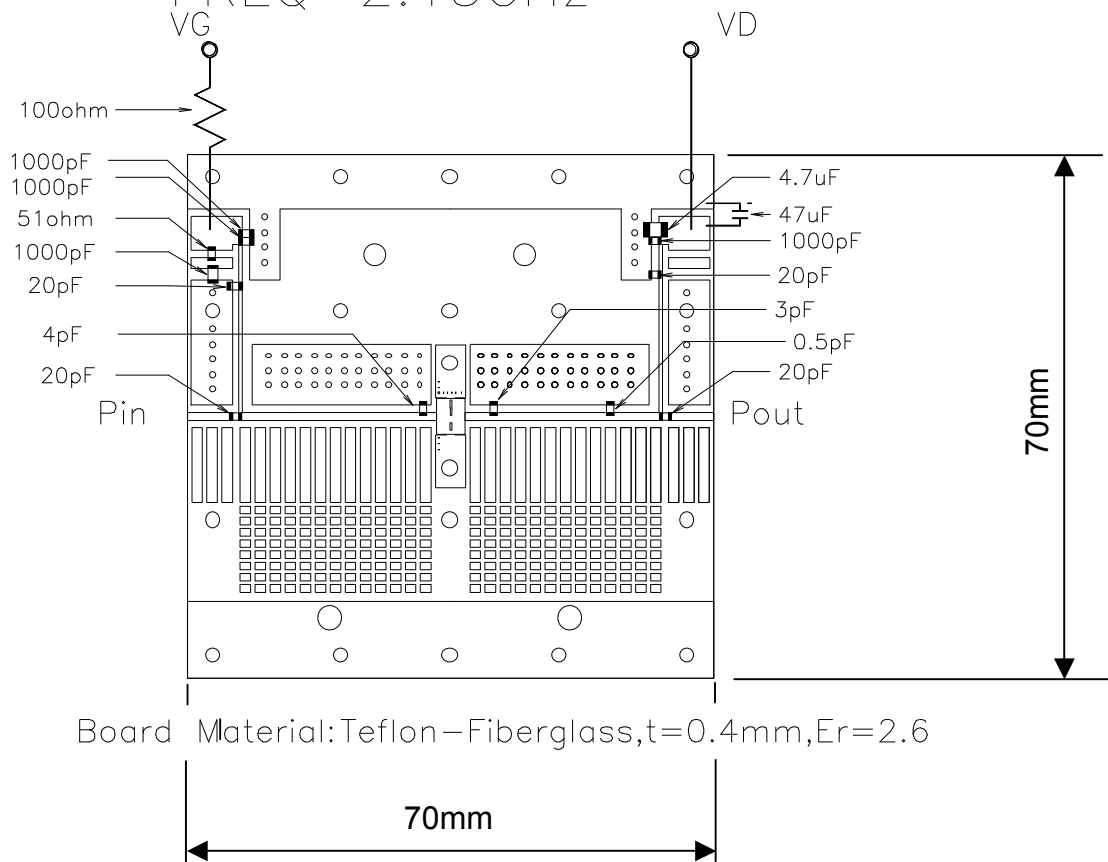
**MGF0952P S PARAMETERS** (Ta=25°C,VD=10V,ID=700mA)

| !freq. | S11   |         | S21   |       | S12   |       | S22   |         |
|--------|-------|---------|-------|-------|-------|-------|-------|---------|
| !(GHz) | (mag) | (ang)   | (mag) | (ang) | (mag) | (ang) | (mag) | (ang)   |
| 0.60   | 0.941 | -155.46 | 3.198 | 95.74 | 0.020 | 14.53 | 0.775 | -176.77 |
| 0.80   | 0.945 | -161.45 | 2.434 | 90.37 | 0.020 | 12.33 | 0.777 | -176.95 |
| 1.00   | 0.945 | -165.05 | 1.970 | 86.23 | 0.021 | 12.00 | 0.777 | -176.88 |
| 1.20   | 0.946 | -167.53 | 1.656 | 82.72 | 0.021 | 10.97 | 0.776 | -176.62 |
| 1.40   | 0.948 | -169.74 | 1.383 | 79.43 | 0.020 | 11.07 | 0.784 | -176.51 |
| 1.60   | 0.949 | -170.98 | 1.223 | 76.56 | 0.020 | 11.75 | 0.783 | -176.15 |
| 1.80   | 0.945 | -172.20 | 1.097 | 73.77 | 0.020 | 9.96  | 0.782 | -175.84 |
| 2.00   | 0.943 | -173.14 | 0.998 | 71.28 | 0.020 | 10.52 | 0.783 | -175.41 |
| 2.20   | 0.944 | -173.68 | 0.918 | 68.77 | 0.020 | 11.92 | 0.782 | -174.89 |
| 2.40   | 0.946 | -174.29 | 0.855 | 66.48 | 0.020 | 12.32 | 0.782 | -174.38 |
| 2.60   | 0.946 | -174.91 | 0.802 | 64.21 | 0.020 | 11.26 | 0.781 | -173.87 |
| 2.80   | 0.945 | -175.53 | 0.755 | 61.97 | 0.020 | 10.49 | 0.781 | -173.41 |
| 3.00   | 0.945 | -176.04 | 0.717 | 59.85 | 0.021 | 10.21 | 0.780 | -172.87 |
| 3.20   | 0.942 | -176.30 | 0.681 | 57.82 | 0.021 | 8.73  | 0.780 | -172.57 |
| 3.40   | 0.950 | -176.75 | 0.658 | 55.70 | 0.020 | 5.23  | 0.785 | -172.11 |
| 3.60   | 0.945 | -178.34 | 0.624 | 53.05 | 0.018 | 4.47  | 0.783 | -172.82 |
| 3.80   | 0.942 | -178.98 | 0.600 | 51.01 | 0.018 | 12.59 | 0.778 | -172.69 |
| 4.00   | 0.940 | -179.40 | 0.581 | 48.78 | 0.019 | 16.08 | 0.776 | -172.55 |
| 4.20   | 0.942 | 179.63  | 0.562 | 46.21 | 0.020 | 13.00 | 0.776 | -173.07 |
| 4.40   | 0.942 | 178.51  | 0.543 | 43.59 | 0.021 | 12.22 | 0.778 | -173.71 |
| 4.60   | 0.941 | 177.39  | 0.525 | 40.94 | 0.020 | 9.78  | 0.779 | -174.47 |
| 4.80   | 0.941 | 176.53  | 0.511 | 38.30 | 0.021 | 8.54  | 0.779 | -175.57 |
| 5.00   | 0.940 | 175.20  | 0.495 | 35.58 | 0.022 | 6.78  | 0.780 | -176.58 |
| 5.20   | 0.939 | 173.69  | 0.481 | 32.70 | 0.021 | 4.96  | 0.783 | -177.54 |
| 5.40   | 0.938 | 172.28  | 0.467 | 30.04 | 0.021 | 3.17  | 0784  | -178.54 |
| 5.60   | 0.936 | 171.29  | 0.457 | 27.42 | 0.022 | 1.75  | 0.786 | -179.32 |
| 5.80   | 0.936 | 169.82  | 0.449 | 24.82 | 0.022 | 0.51  | 0.790 | 179.87  |
| 6.00   | 0.933 | 167.83  | 0.440 | 21.94 | 0.023 | -0.94 | 0.792 | 178.97  |
| 6.20   | 0.932 | 166.34  | 0.430 | 19.46 | 0.023 | -1.38 | 0.794 | 178.44  |
| 6.40   | 0.933 | 165.13  | 0.424 | 17.22 | 0.023 | -2.56 | 0.797 | 178.03  |
| 6.60   | 0.931 | 163.73  | 0.421 | 14.95 | 0.024 | -2.05 | 0.801 | 177.89  |
| 6.80   | 0.930 | 162.01  | 0.420 | 12.61 | 0.024 | -3.27 | 0.804 | 177.64  |
| 7.00   | 0.931 | 160.33  | 0.418 | 10.17 | 0.025 | -2.88 | 0.807 | 177.45  |

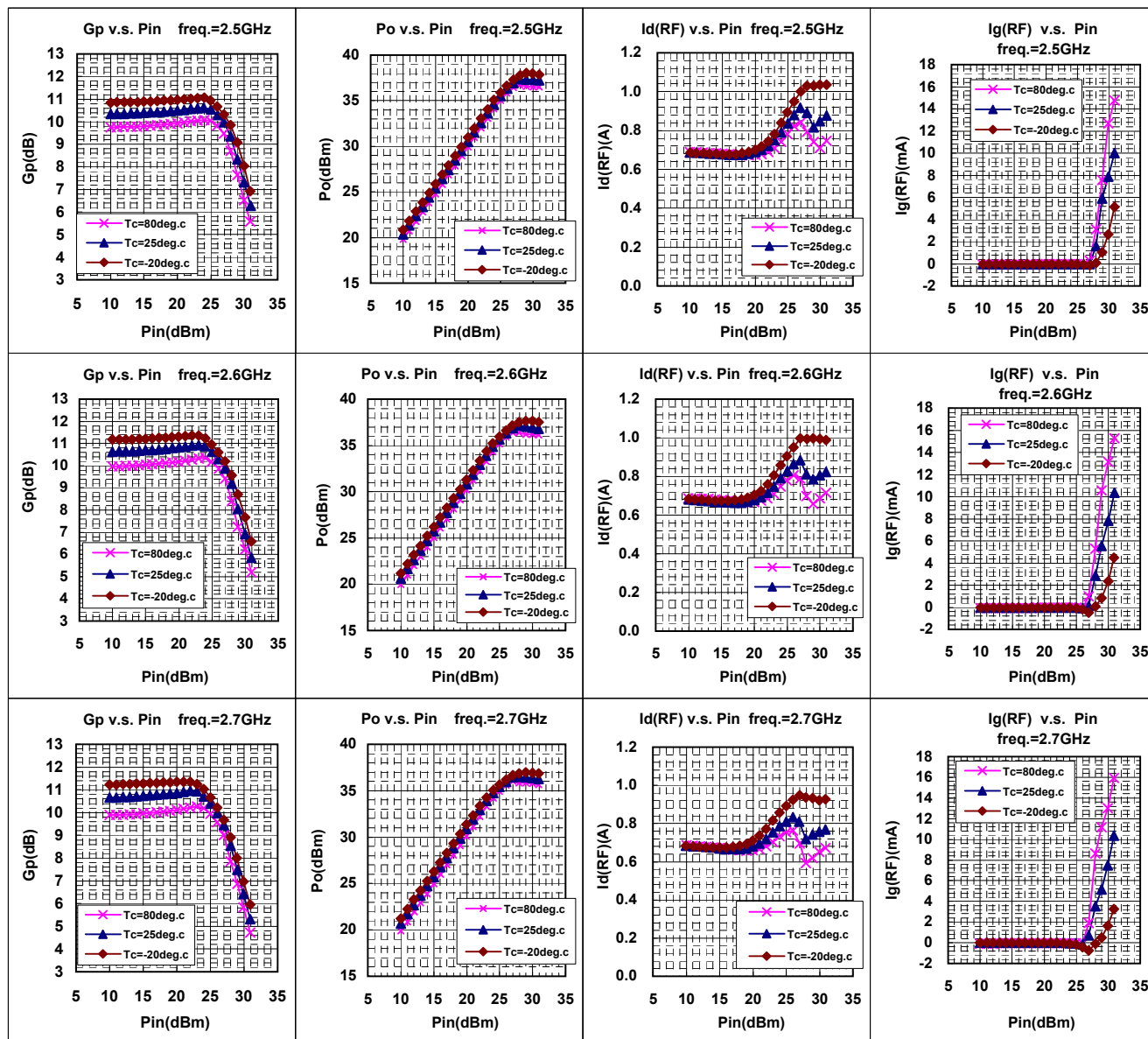

**Fig1. OUTLINE DRAWING**

# MGF0952P TESTFIXTURE

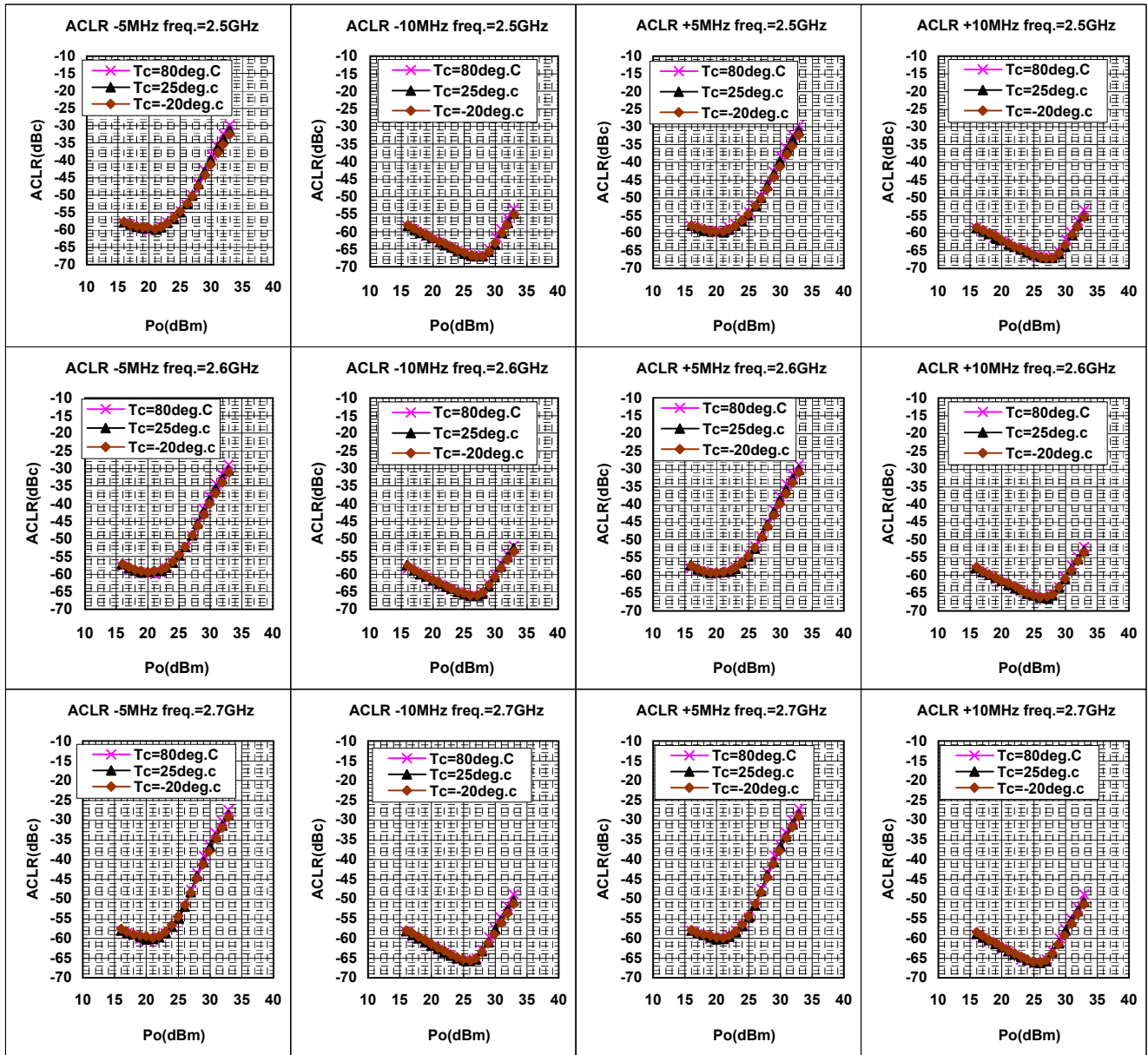
## FREQ=2.15GHz



**MGF0952P RF TEST DATA(CW) VD=10V,Idq=0.7A**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**

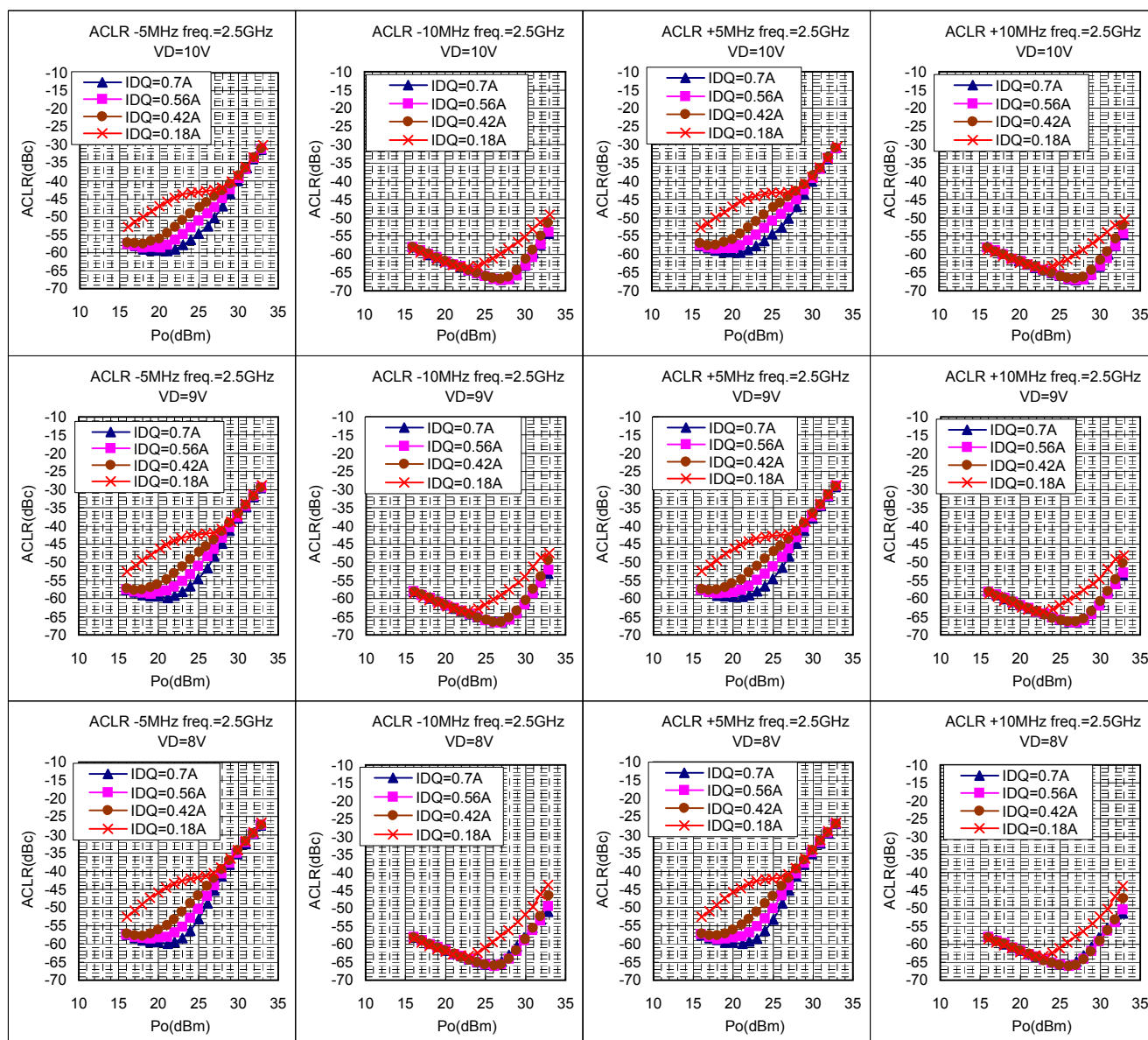


**MGF0952P RF TEST DATA(W-CDMA)      VD=10V,Idq=0.7A**  
**ACLR v.s. Po    3GPP TEST MODEL1 64ch's Single Signal**



# MGF0952P RF TEST DATA(W-CDMA)

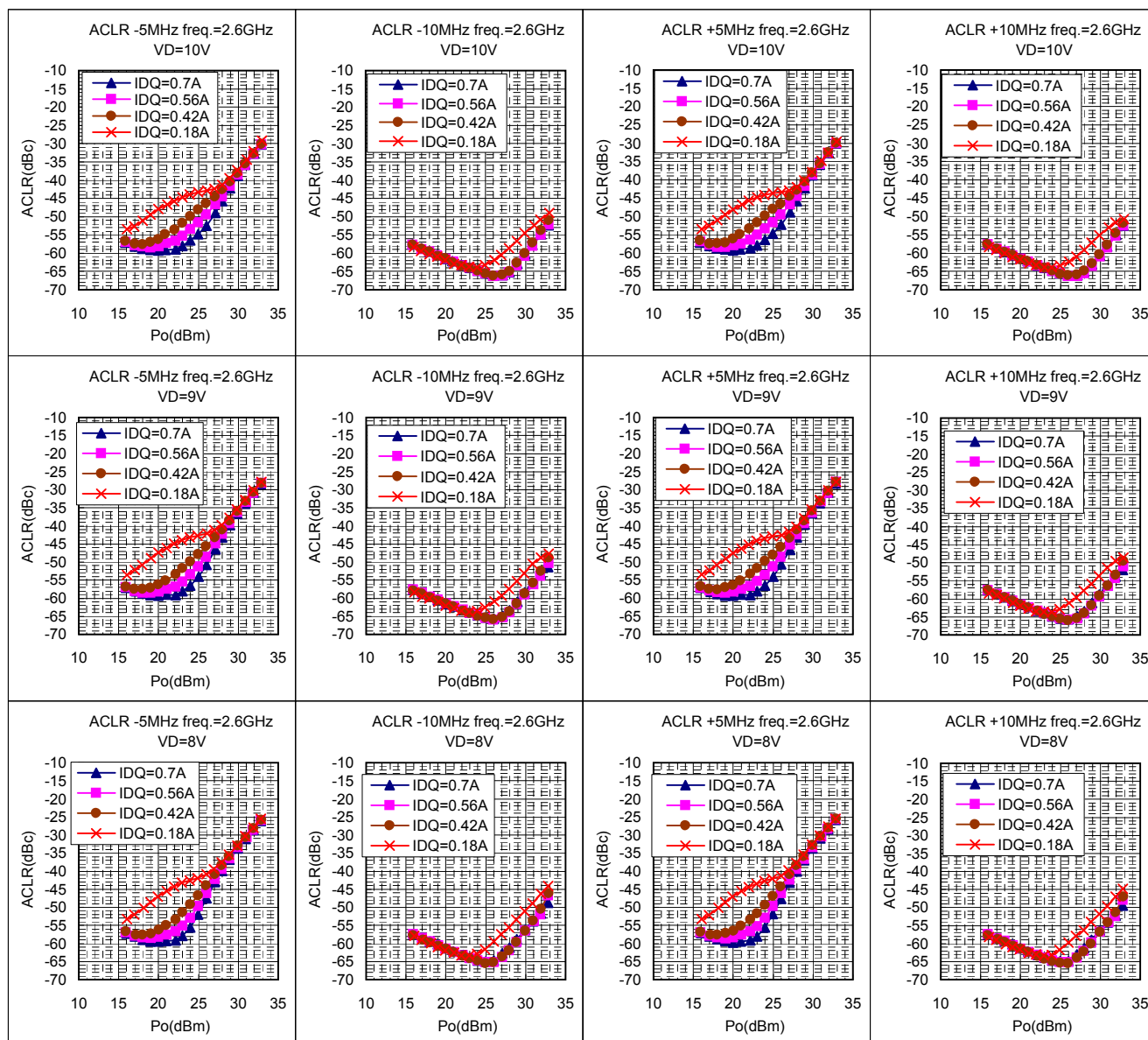
## ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal





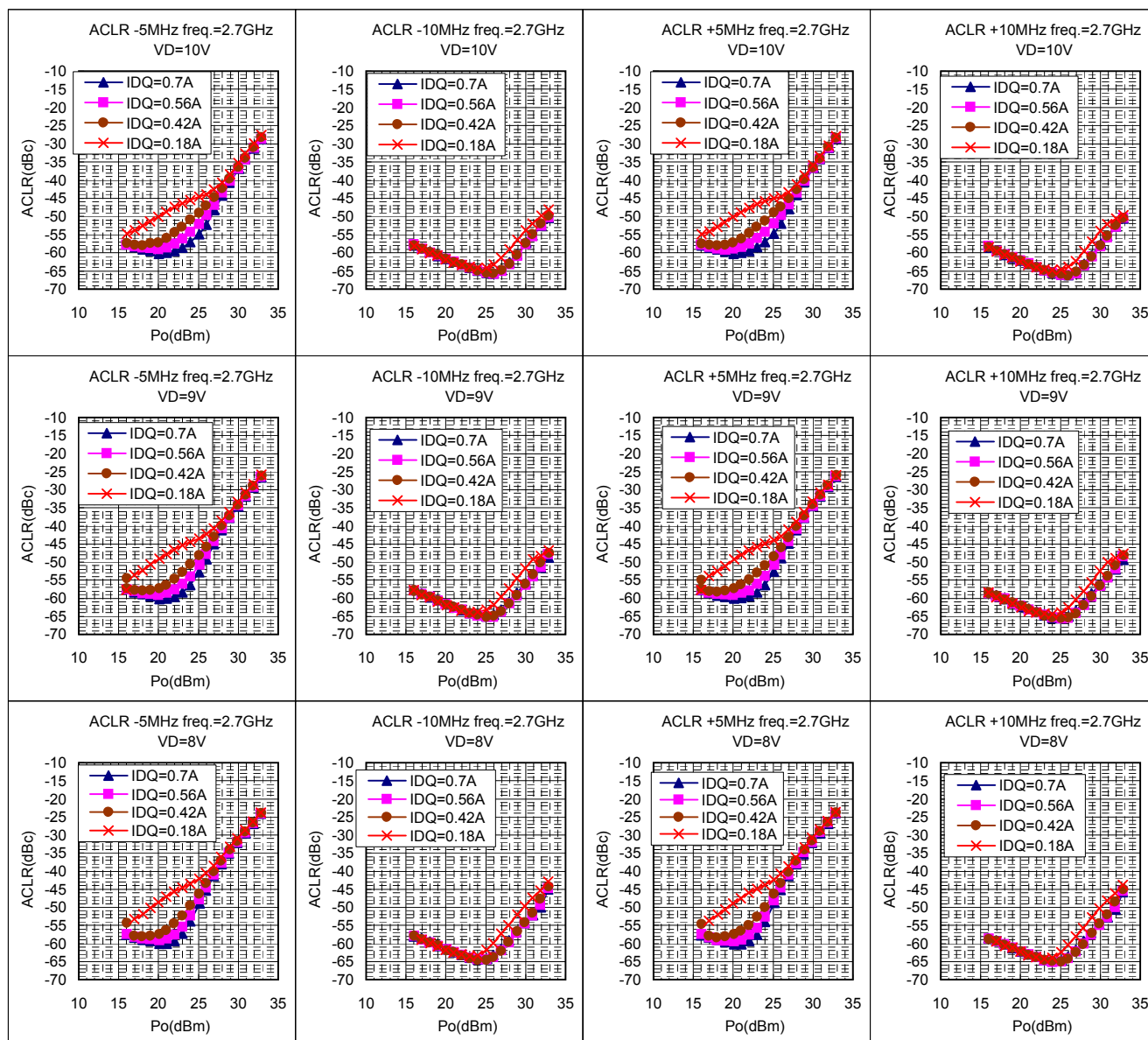
# MGF0952P RF TEST DATA(W-CDMA)

## ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal



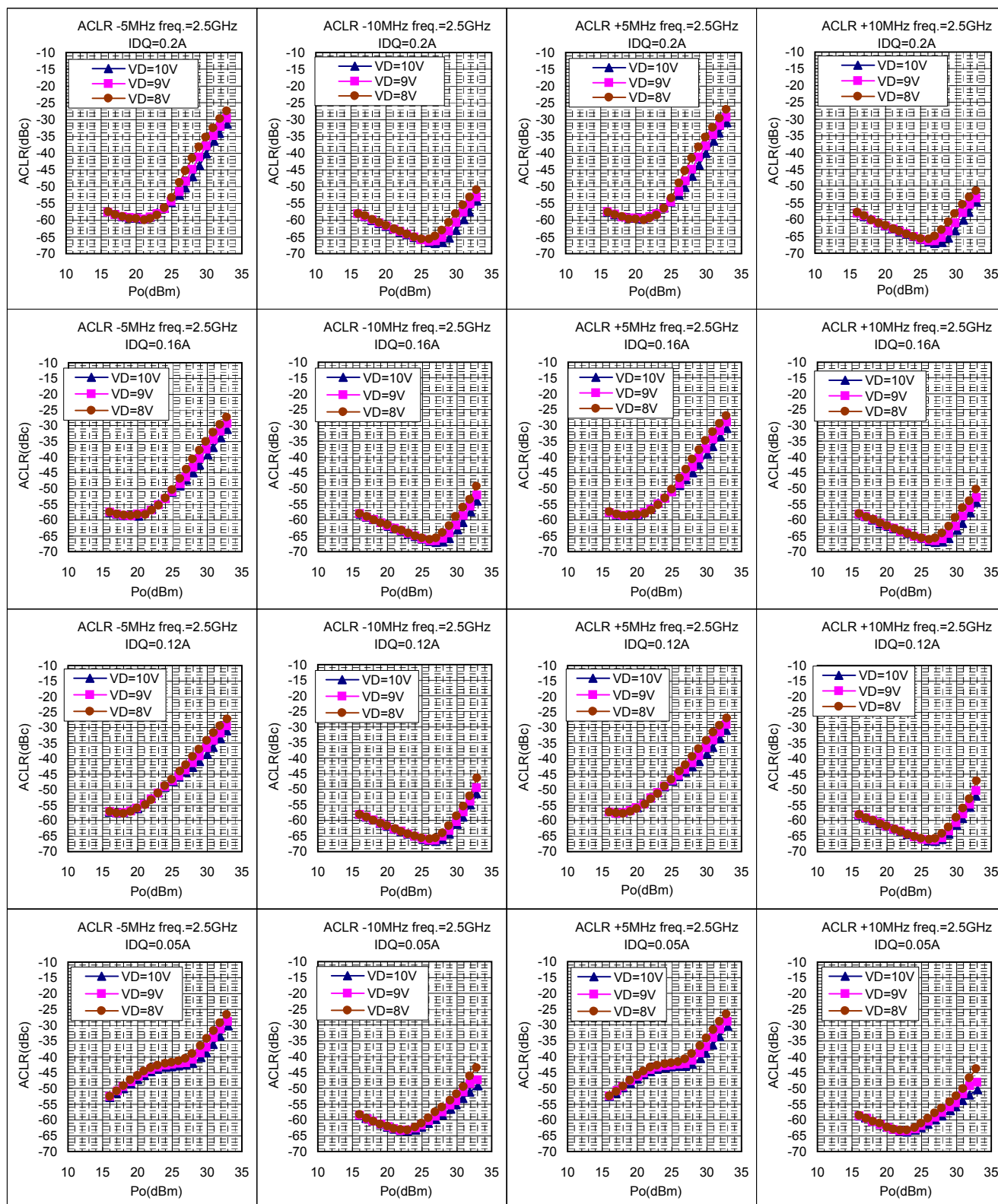
# MGF0952P RF TEST DATA(W-CDMA)

## ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal



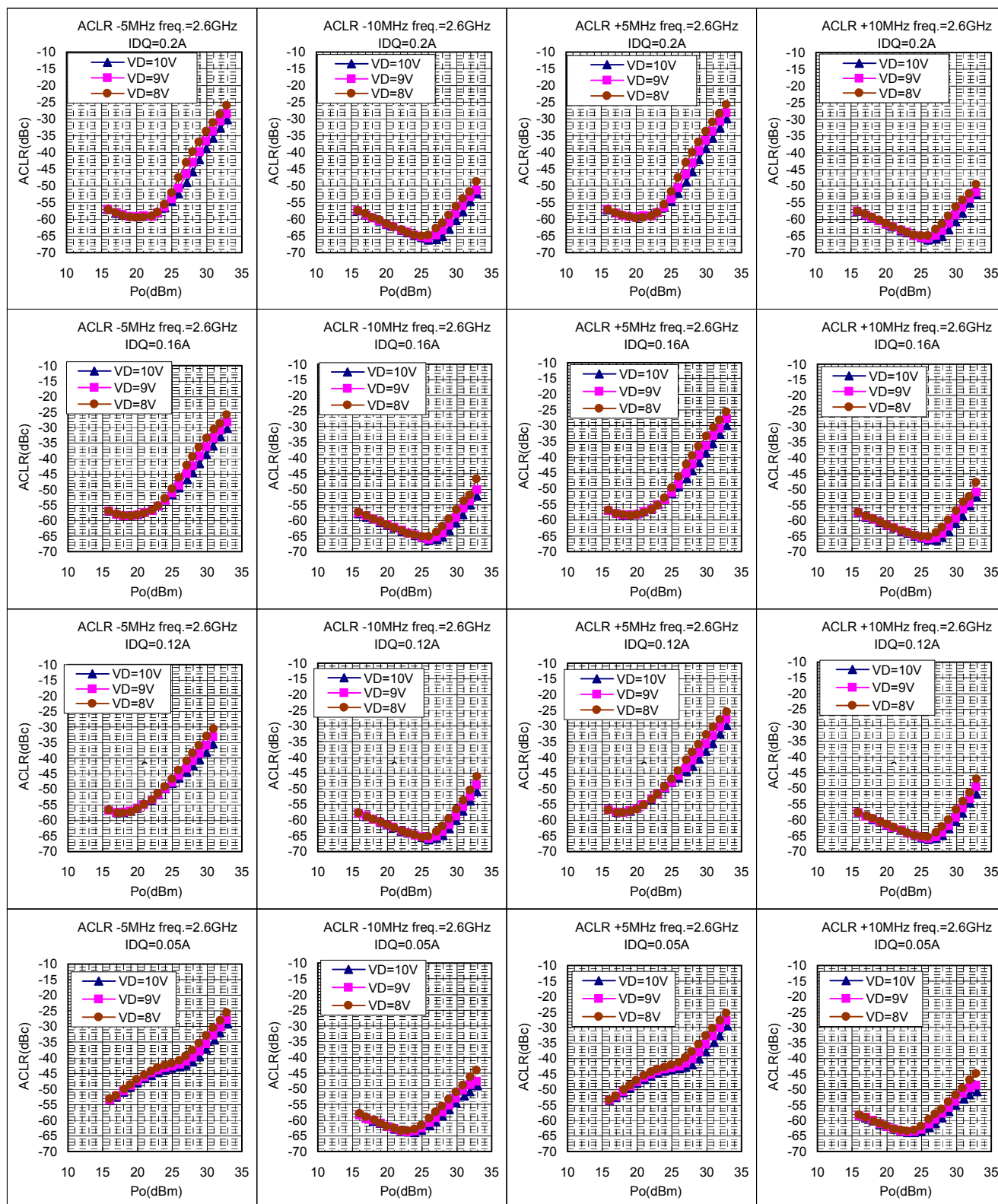
# MGF0952P RF TEST DATA(W-CDMA)

## ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal



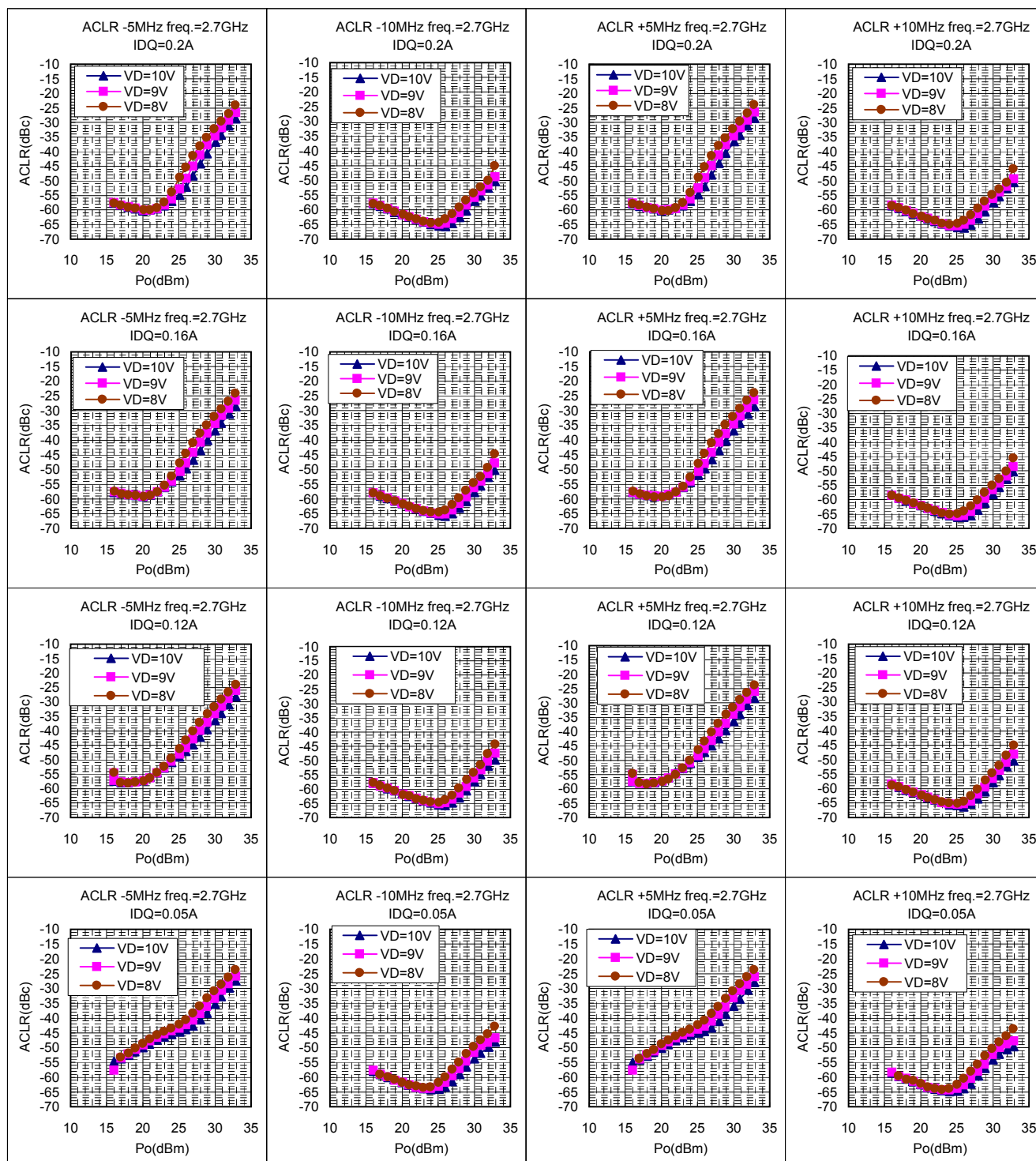
# MGF0952P RF TEST DATA(W-CDMA)

## ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal



# MGF0952P RF TEST DATA(W-CDMA)

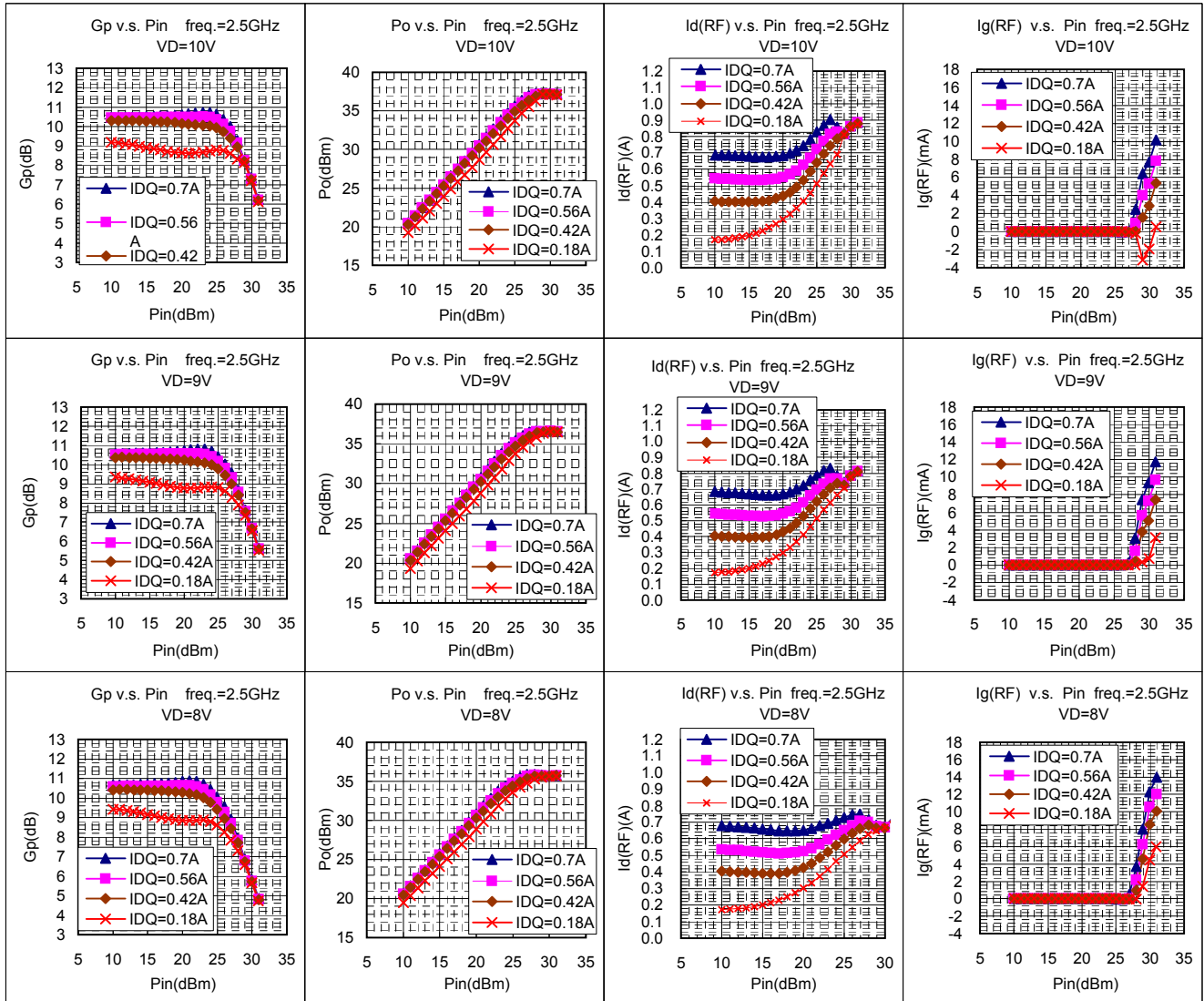
## ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal





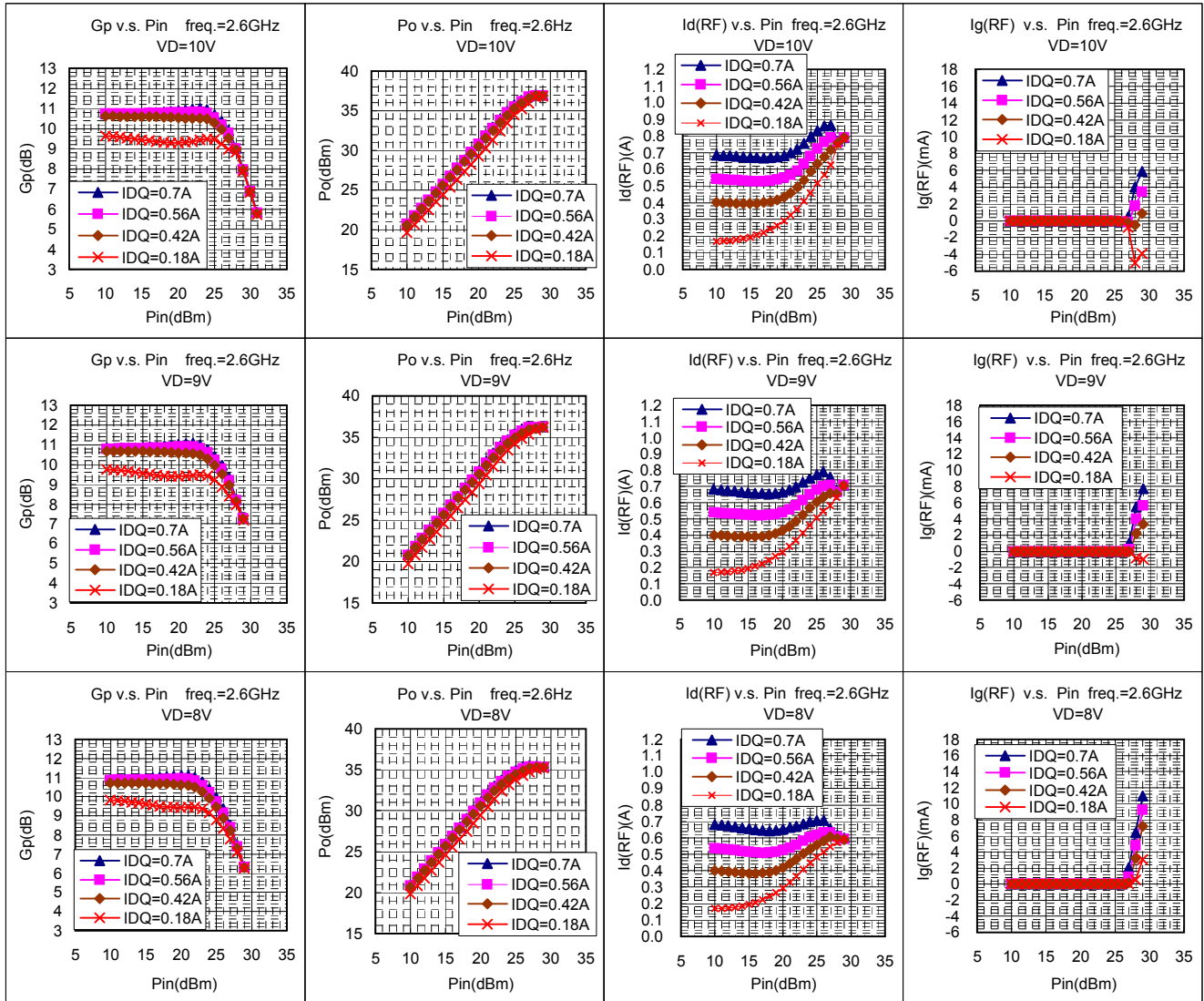
# MGF0952P RF TEST DATA(CW)

## Gp,Po,Id(RF),Ig(RF) v.s. Pin



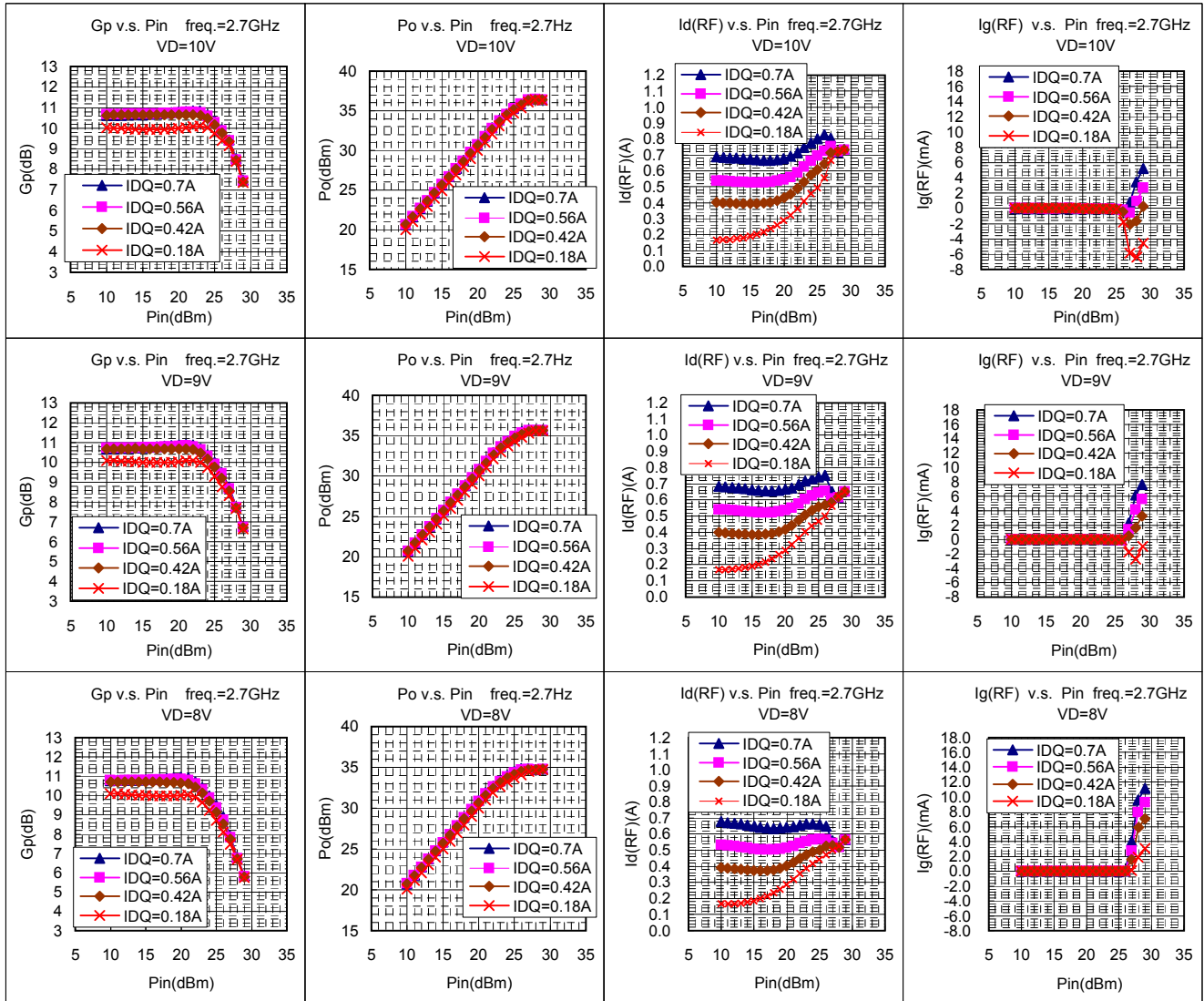
# MGF0952P RF TEST DATA(CW)

## Gp,Po,Id(RF),Ig(RF) v.s. Pin



# MGF0952P RF TEST DATA(CW)

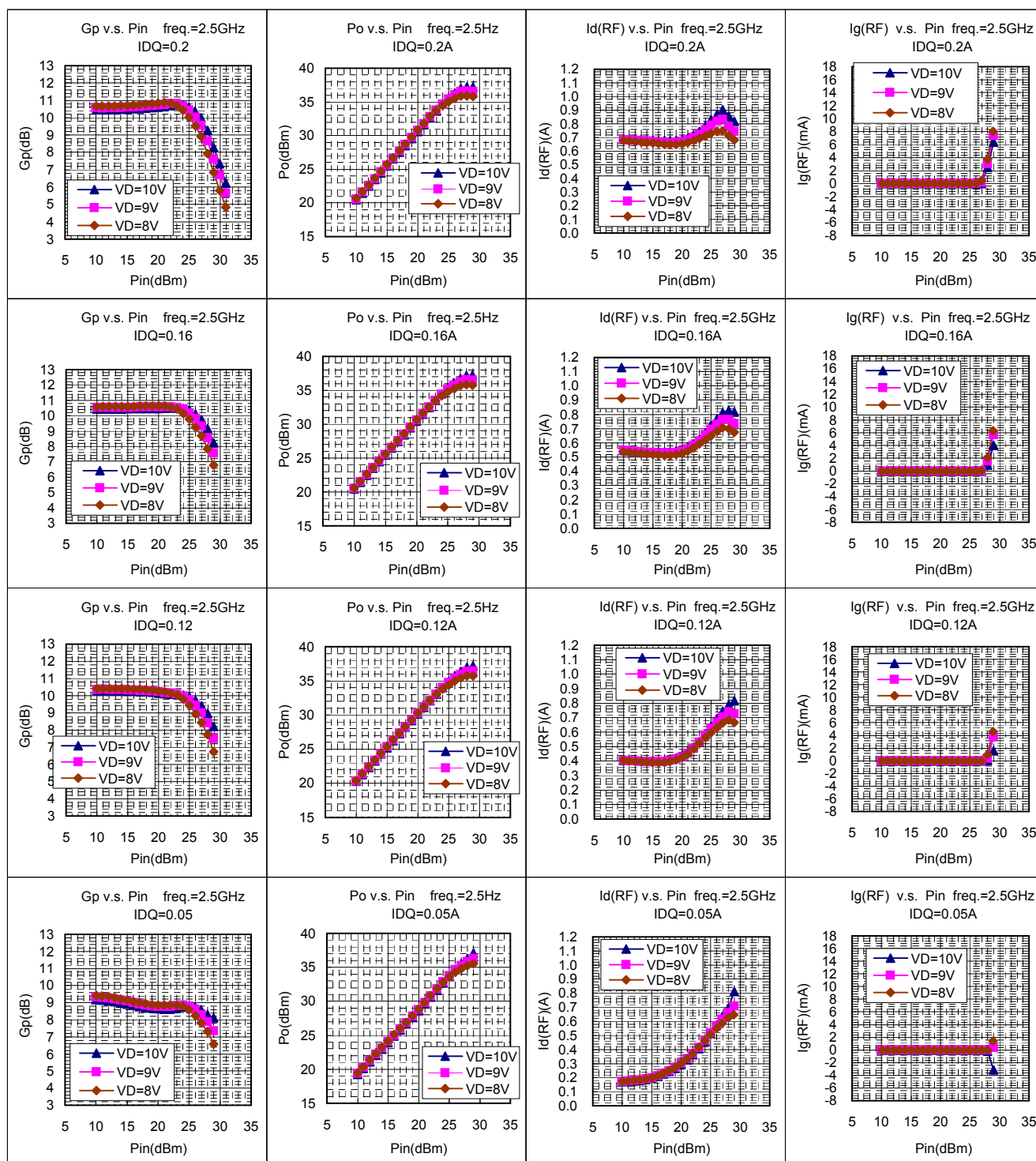
## Gp,Po,Id(RF),Ig(RF) v.s. Pin





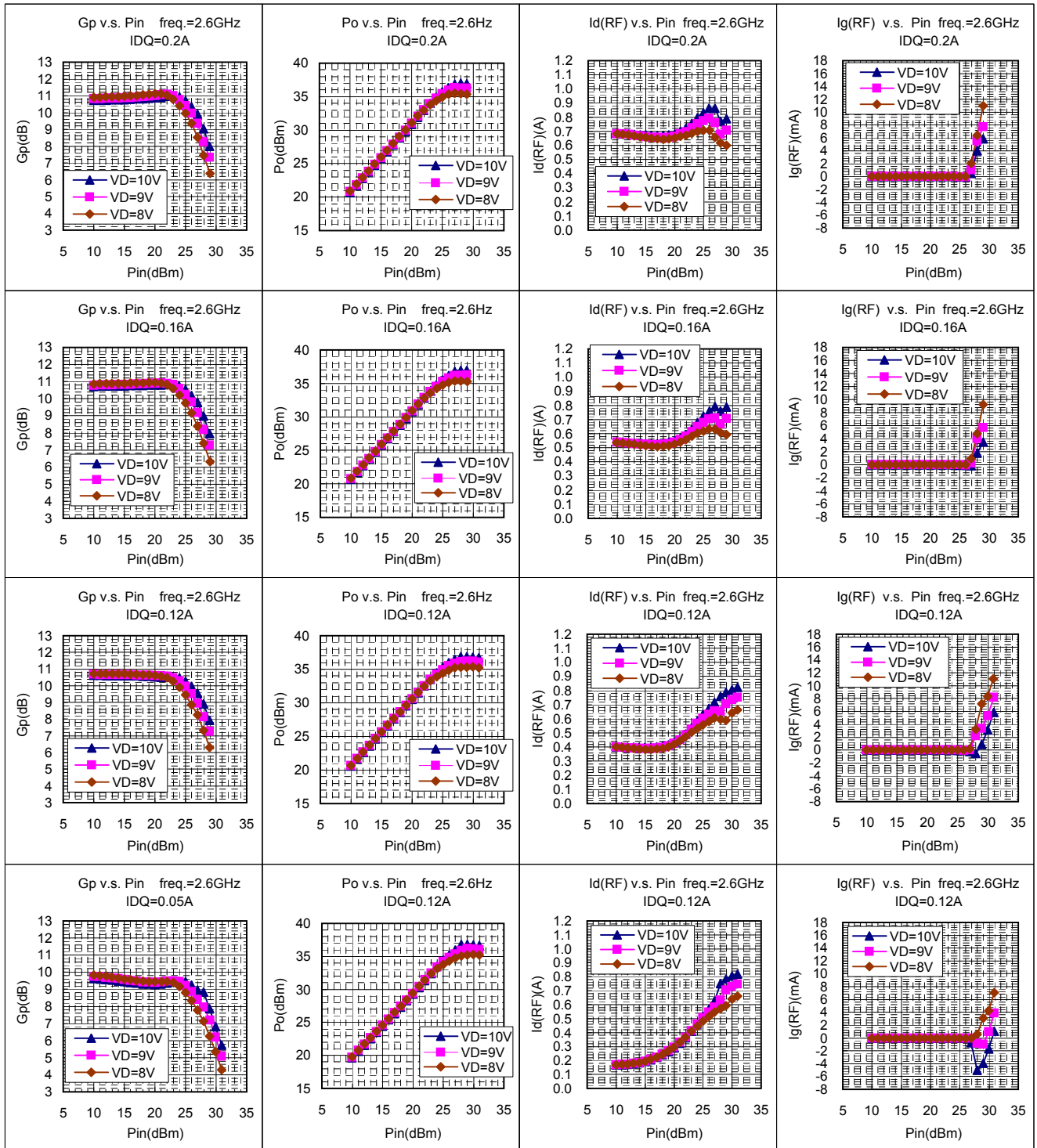
# MGF0952P RF TEST DATA(CW)

## Gp,Po,Id(RF),Ig(RF) v.s. Pin



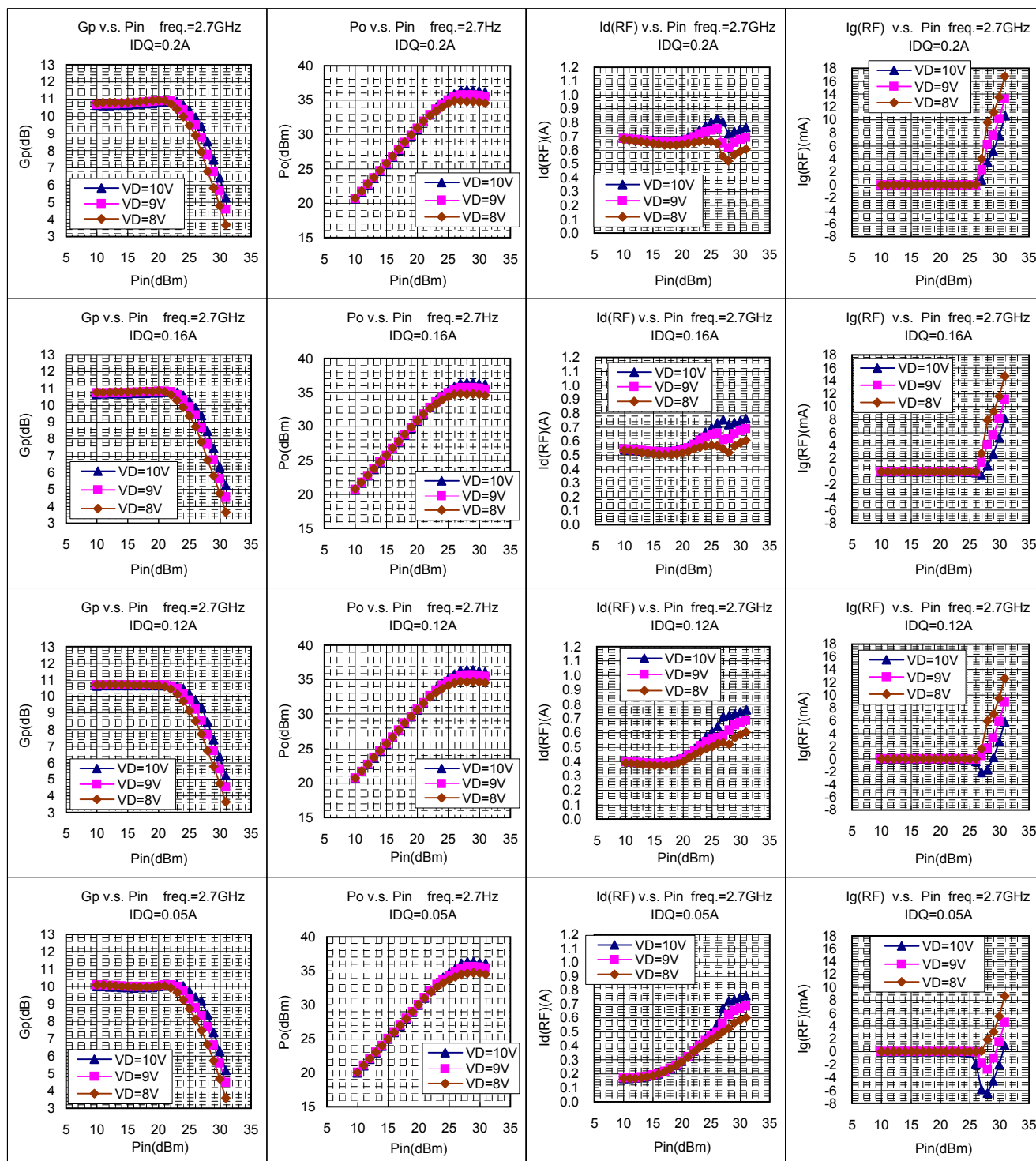
# MGF0952P RF TEST DATA(CW)

## Gp,Po,Id(RF),Ig(RF) v.s. Pin

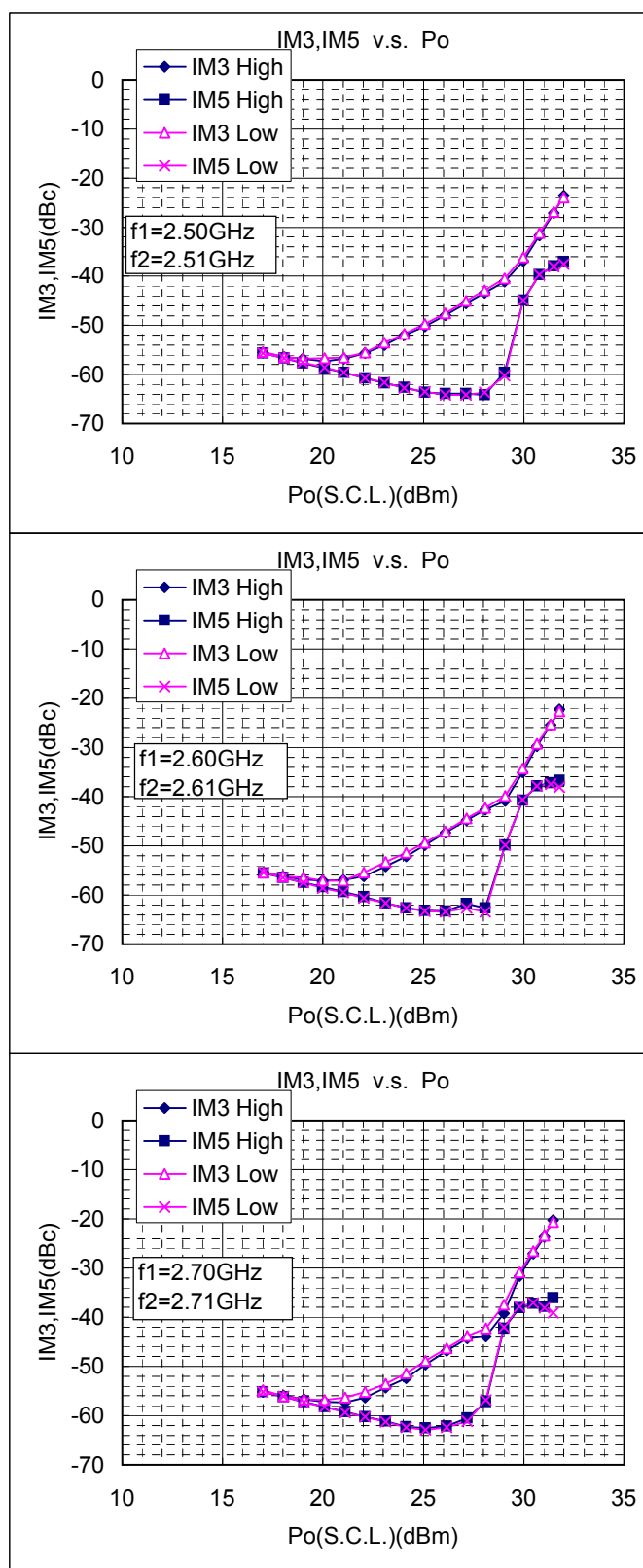


# MGF0952P RF TEST DATA(CW)

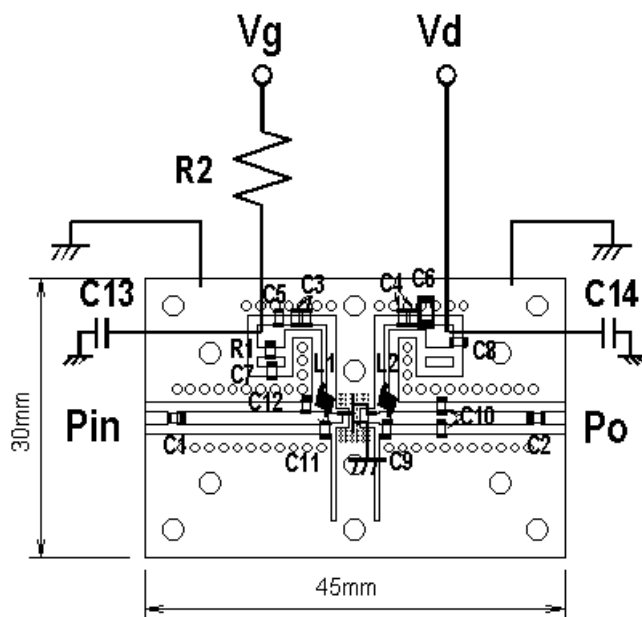
## Gp,Po,Id(RF),Ig(RF) v.s. Pin



**MGF0952P RF TEST DATA     VD=10V, Idq=0.8A**  
**IM3,IM5 v.s. Pin**



# MGF0952P TEST FIXTURE $f=2.6\text{GHz}$

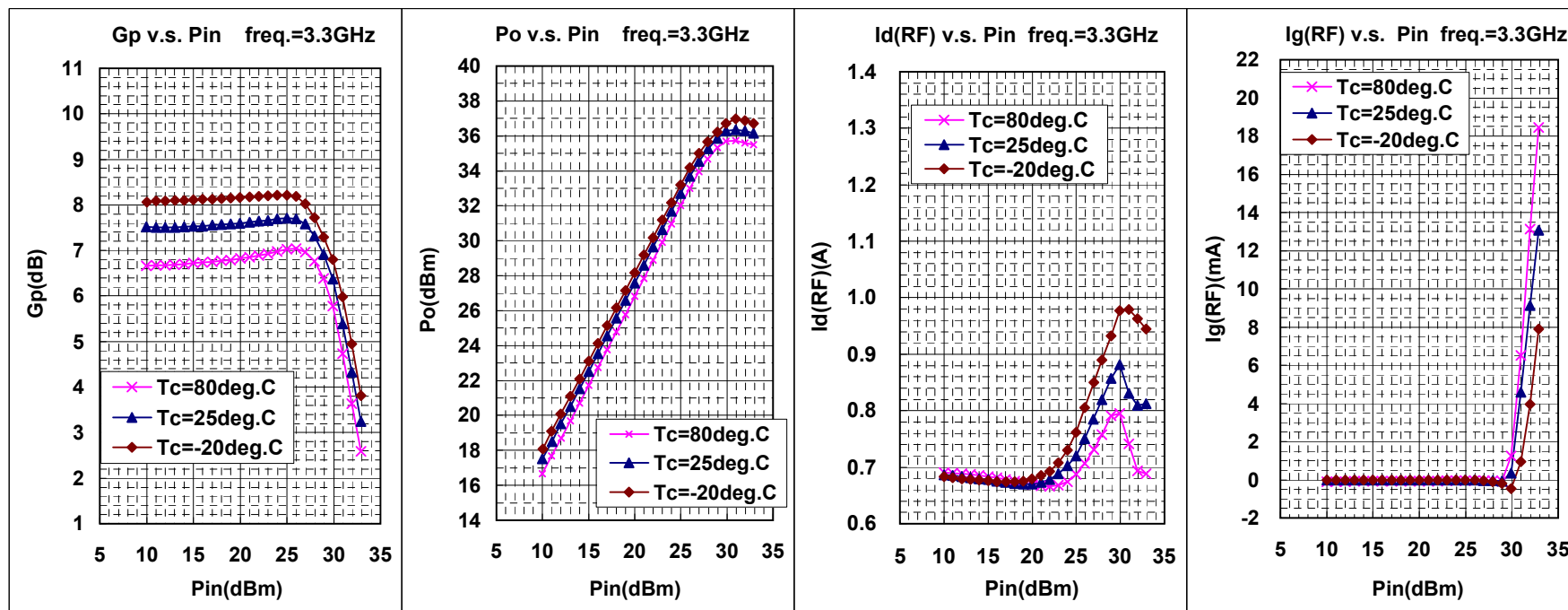


$C1, C2, C3, C4 = 20\text{pF}$   
 $C5, C7, C8 = 1000\text{pF}$   
 $C9, C11 = 2\text{pF}$   
 $C10 = 1\text{pF}$   
 $C13 = 330\mu\text{F}$   
 $C14 = 47\mu\text{F}$   
 $C12 = 0.5\text{pF}$   
 $C6 = 4.7\mu\text{F}$   
 $L1, L2 = 12\text{nH}$   
 $R1 = 51\text{ohm}$   
 $R2 = 100\text{ohm}$

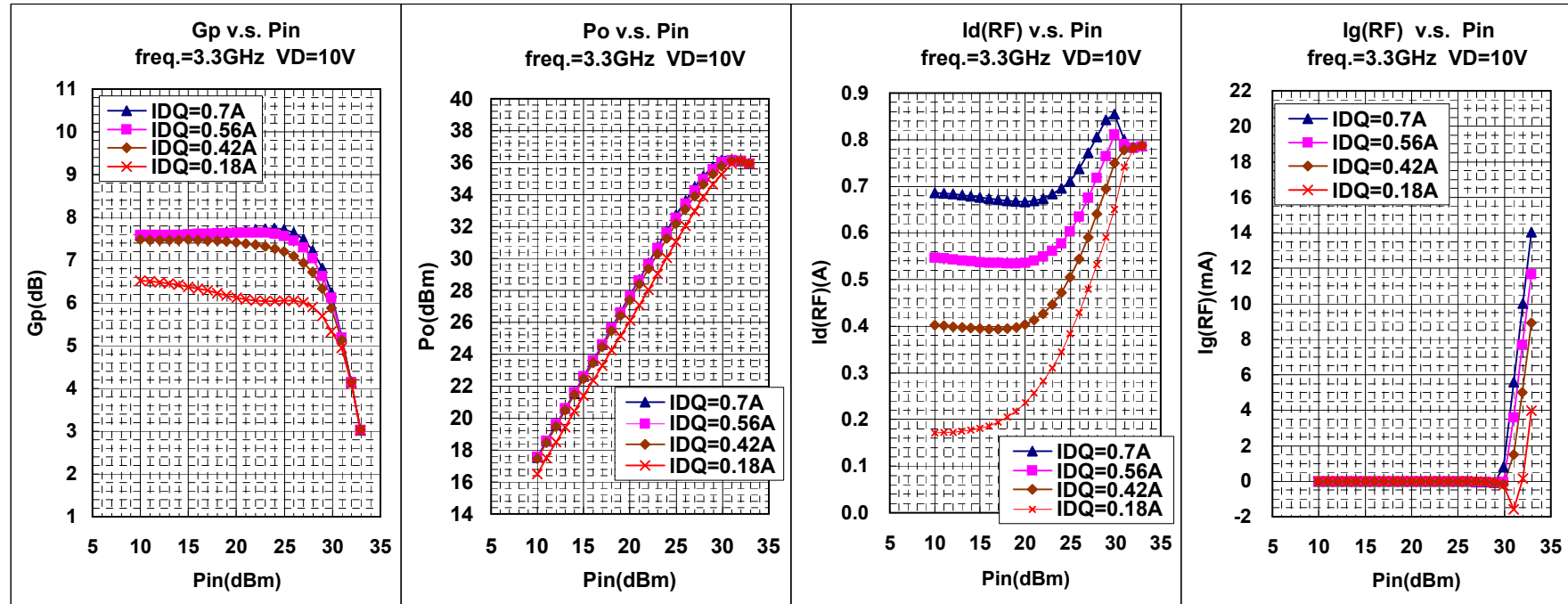
Board material: FR4 Thickness=0.8(mm)  
 Specific dielectric constant=4.4

MGF0952P RF TEST DATA(CW) VD=10V,Idq=0.7A

Gp,Po,Id(RF),Ig(RF) v.s. Pin

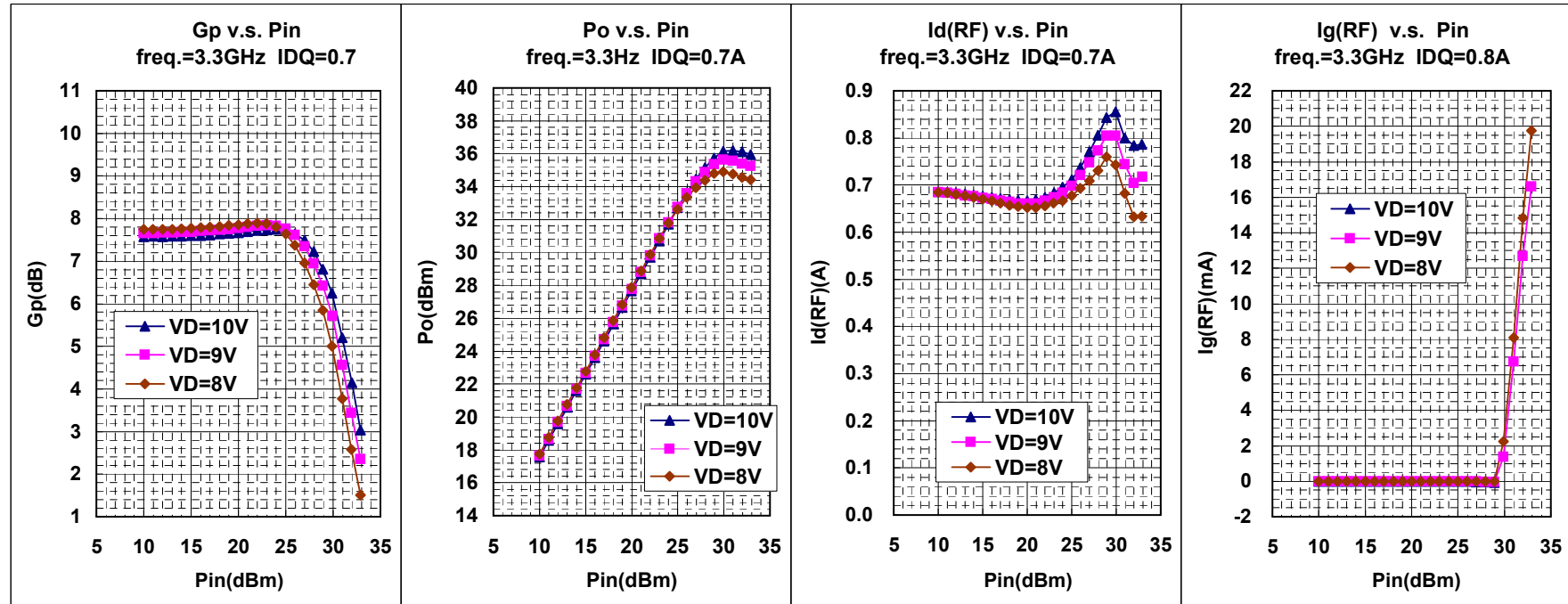


**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**





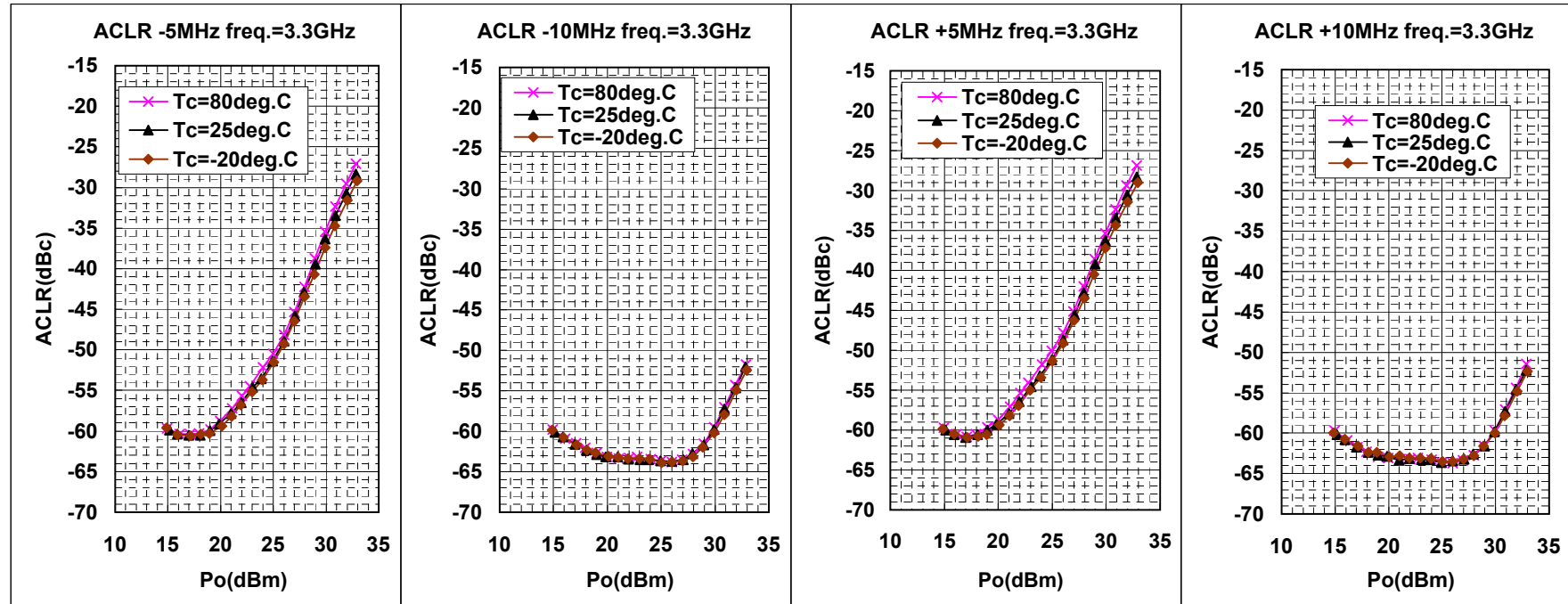
**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**



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MGF0952P RF TEST DATA(W-CDMA) VD=10V,Idq=0.7A  
ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal

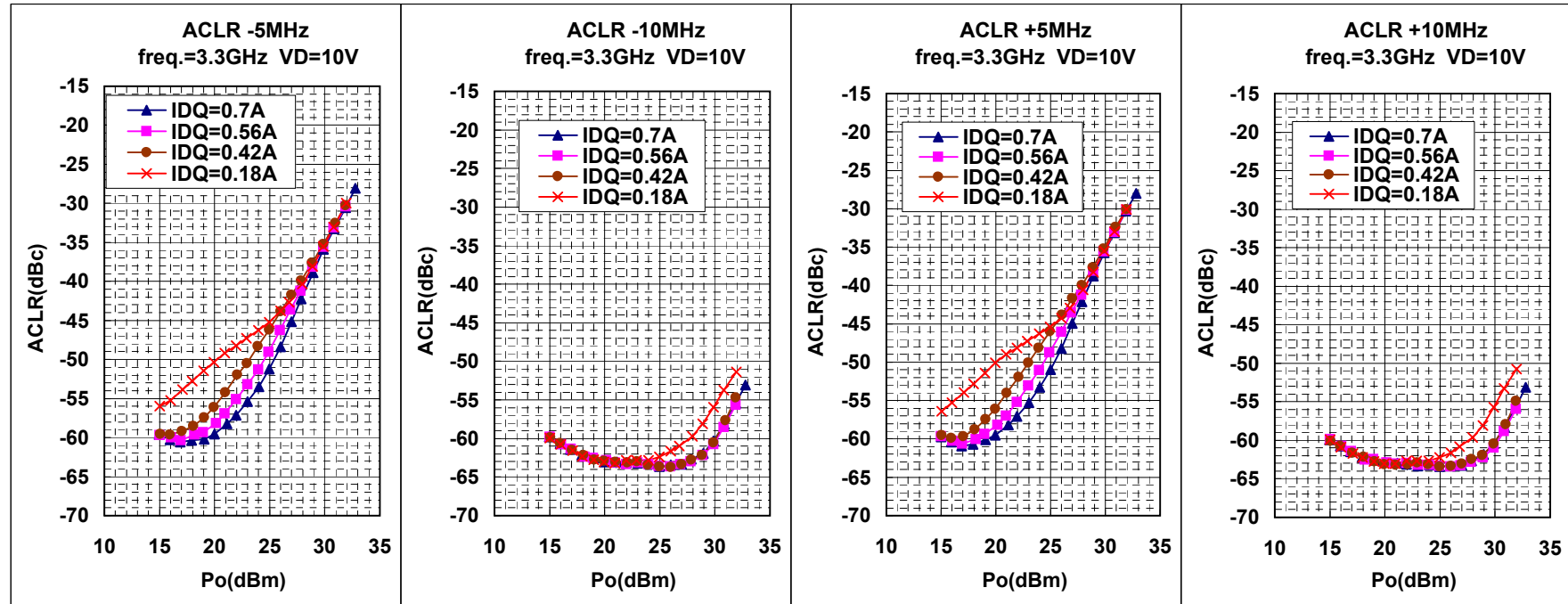
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal**

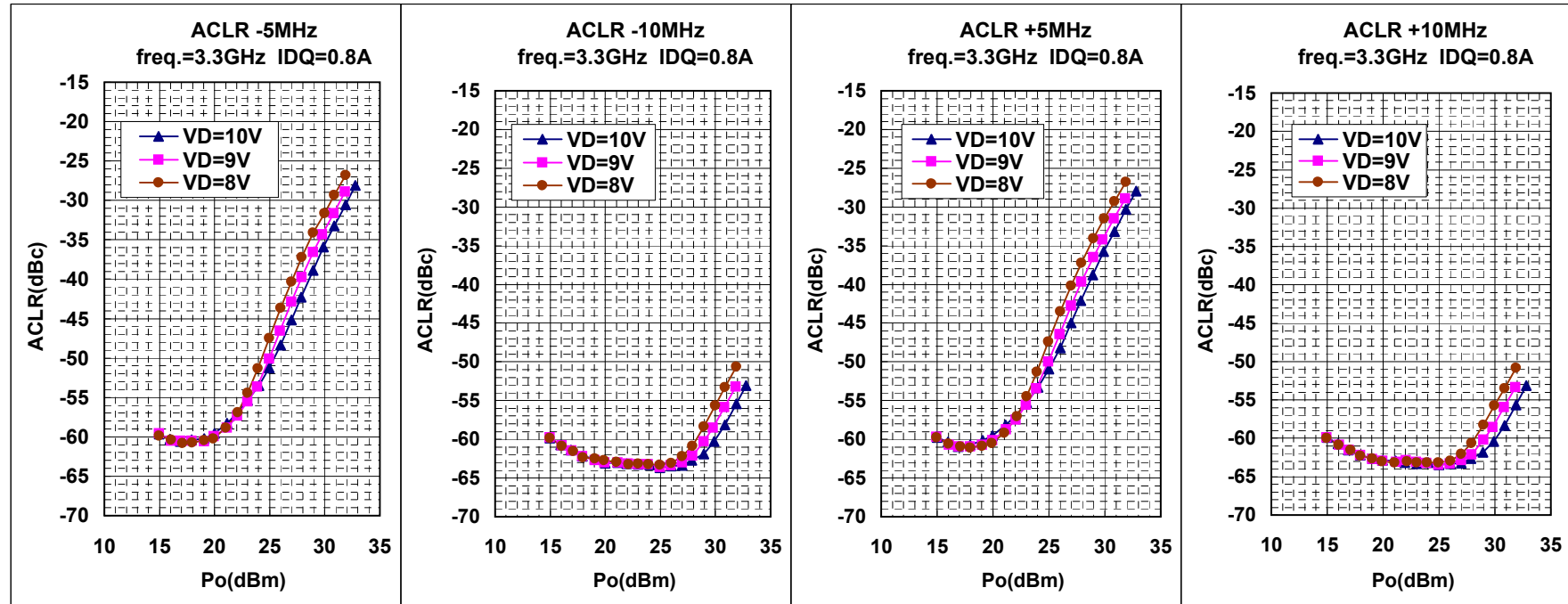
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's Single Signal**

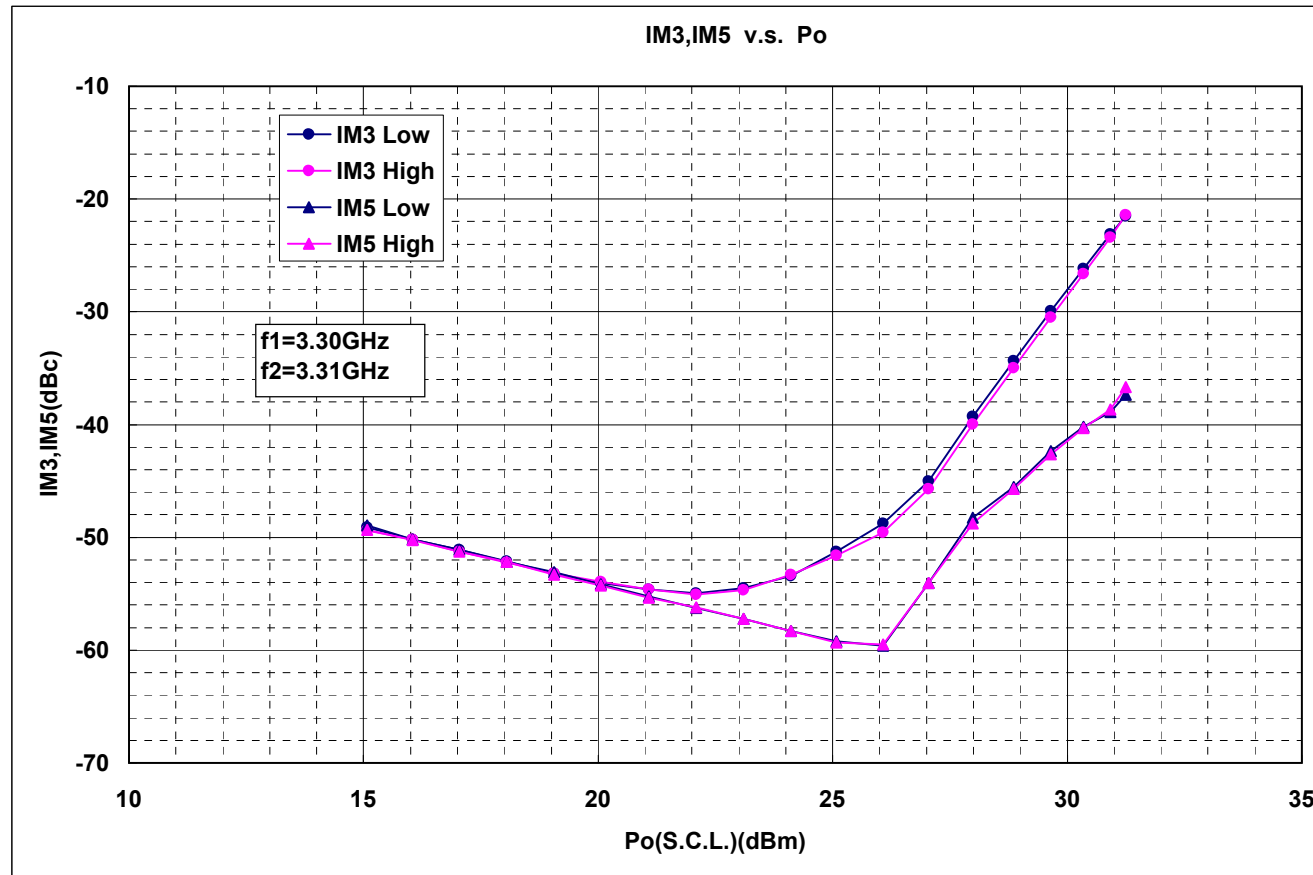
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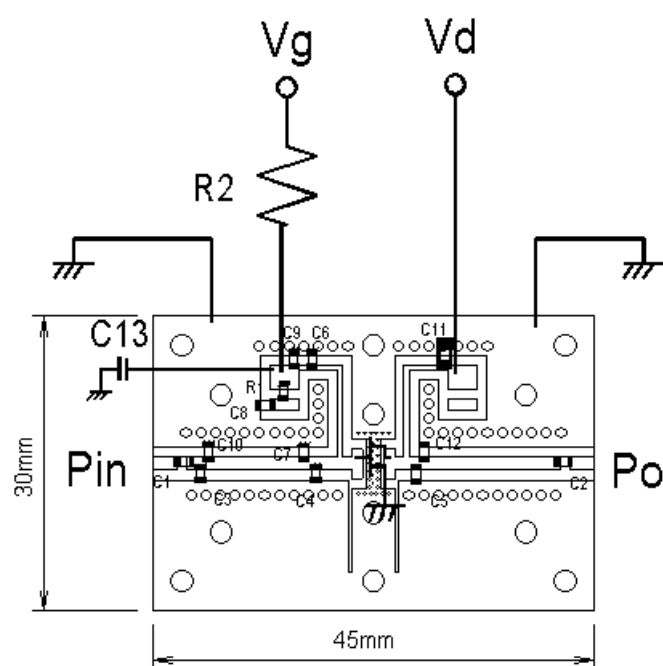
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MGF0952P RF TEST DATA     $V_D=10V, I_{dq}=0.7A$   
IM3,IM5 v.s.  $P_{in}$

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# MGF0952P TEST FIXTURE $f=3.3\text{GHz}$



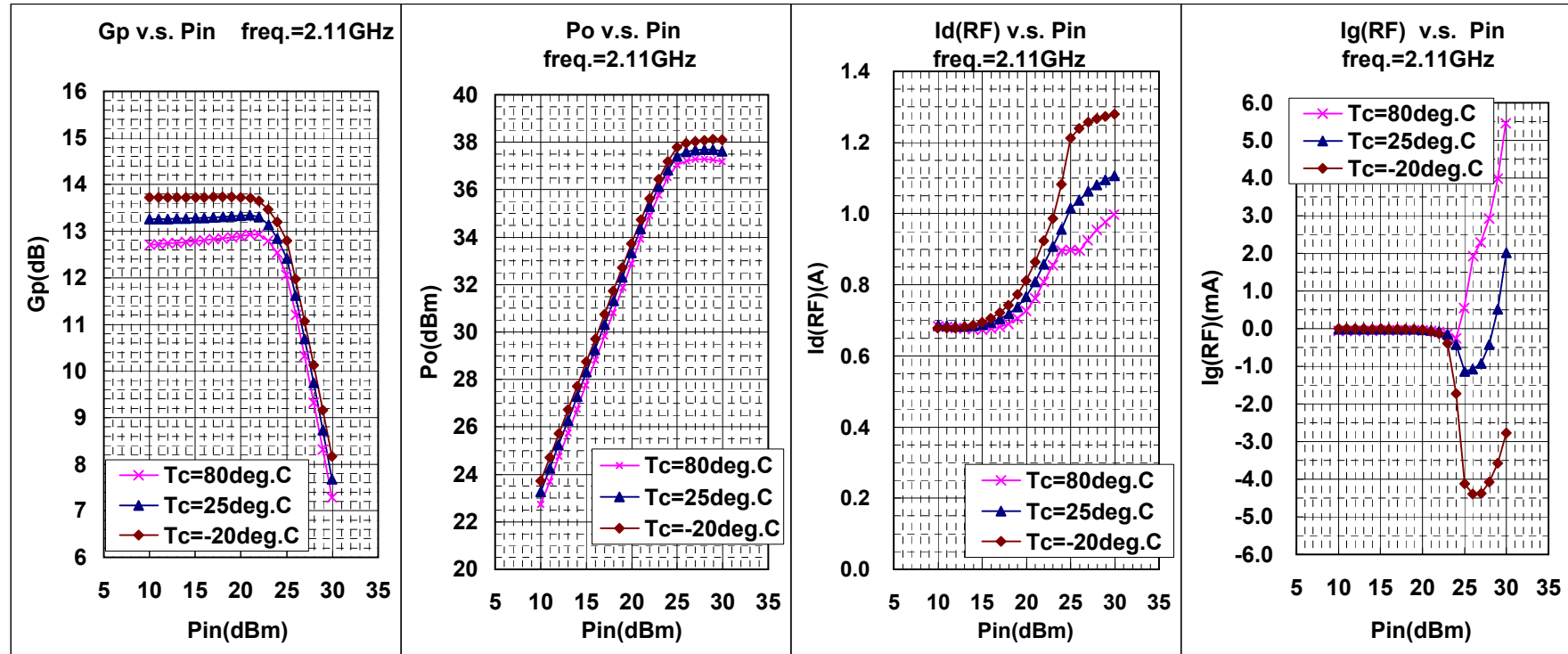
$C1, C2 = 20\text{pF}$   
 $C3, C4, C5 = 1\text{pF}$   
 $C6 = 22\text{pF}$   
 $C7, C10, C12 = 0.5\text{pF}$   
 $C8, C9 = 1000\text{pF}$   
 $C11 = 4.7\mu\text{F}$   
 $C13 = 330\mu\text{F}$   
 $R1 = 51\Omega$   
 $R2 = 100\Omega$

Board material: FR4 Thickness=0.8(mm)  
 Specific dielectric constant=4.4

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MGF0952P RF TEST DATA(CW) VD=10V, IDQ=0.7A  
Gp, Po, Id(RF), Ig(RF) v.s. Pin

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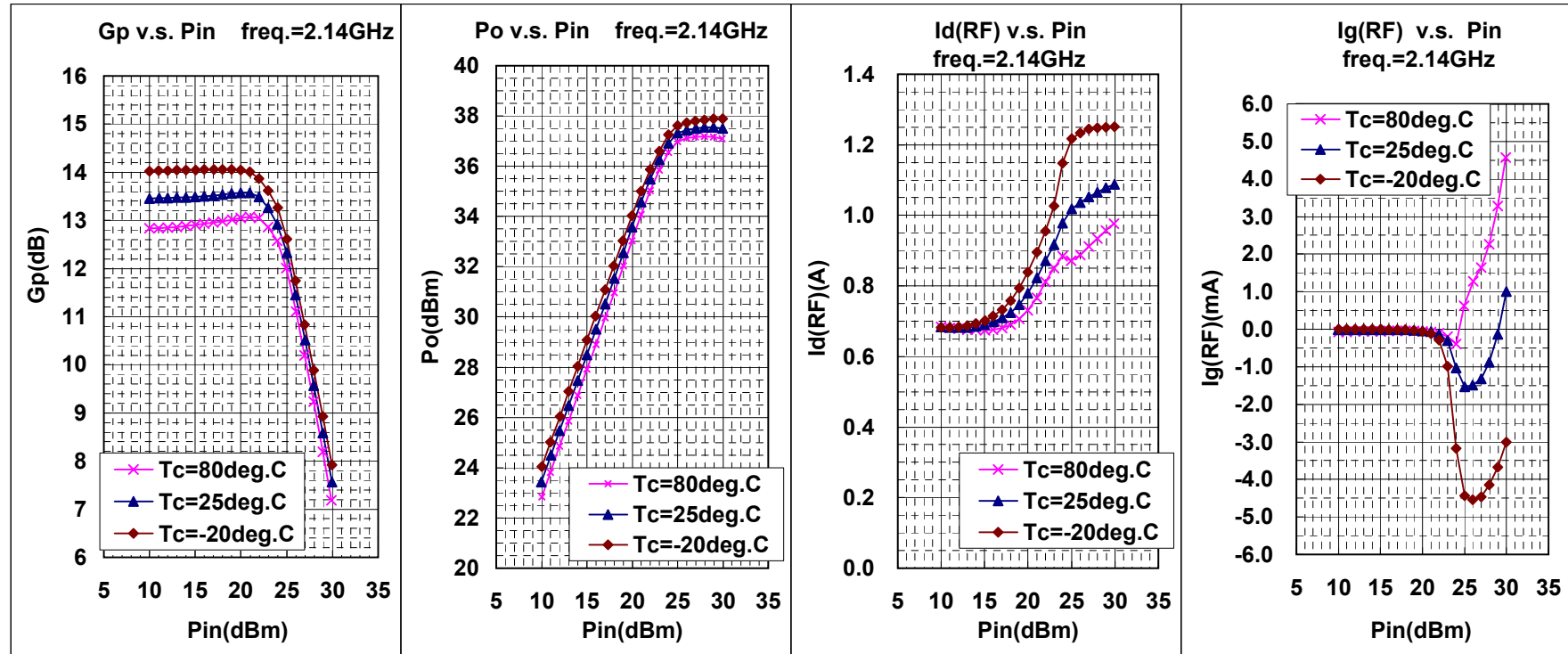




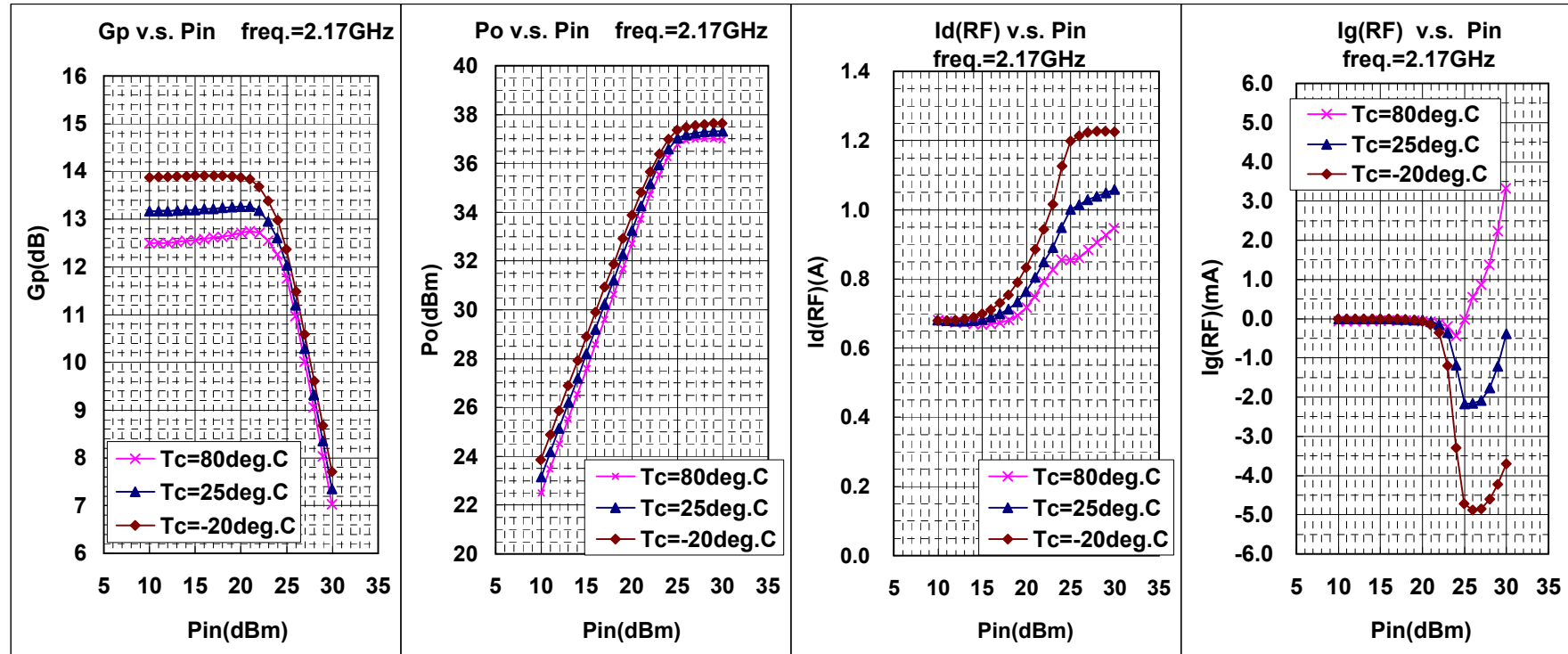
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MGF0952P RF TEST DATA(CW) VD=10V,IDQ=0.7A  
Gp,Po,Id(RF),Ig(RF) v.s. Pin

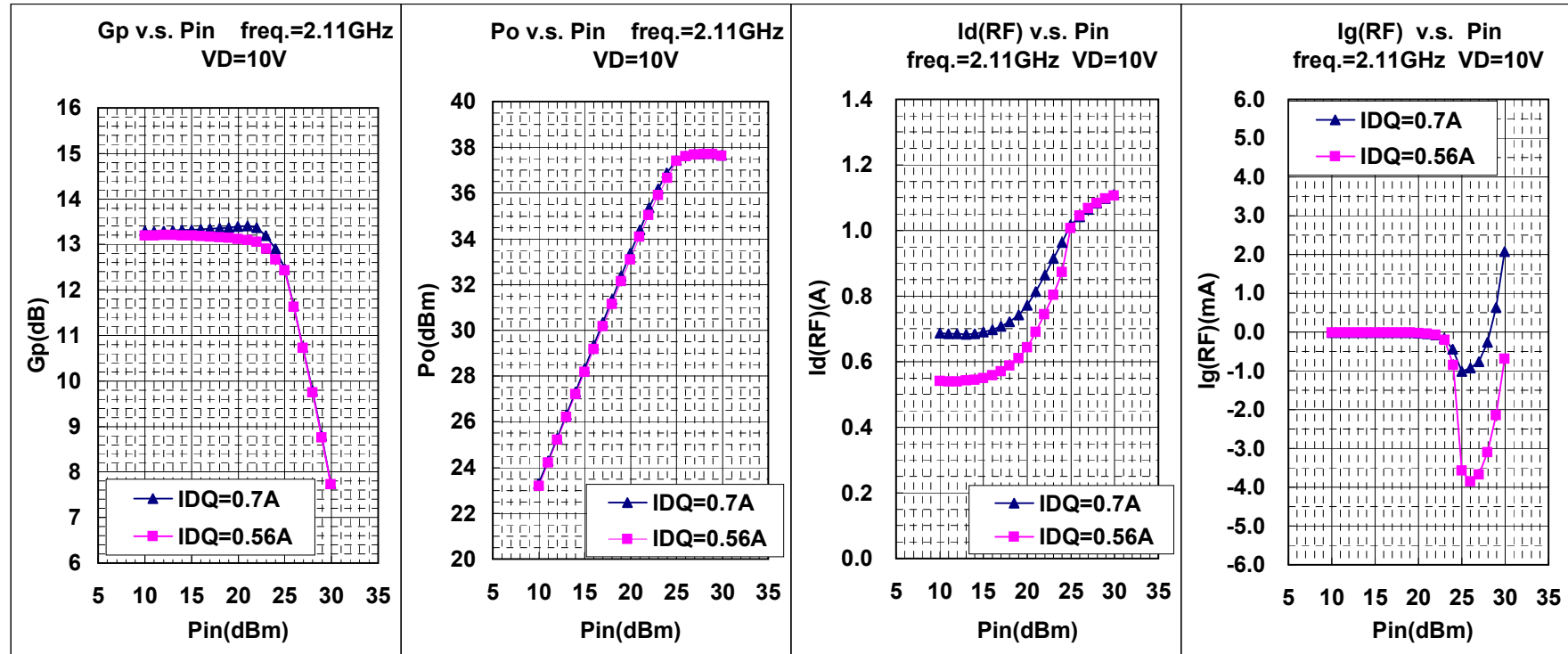
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MGF0952P RF TEST DATA(CW) VD=10V, IDQ=0.7A  
Gp, Po, Id(RF), Ig(RF) v.s. Pin



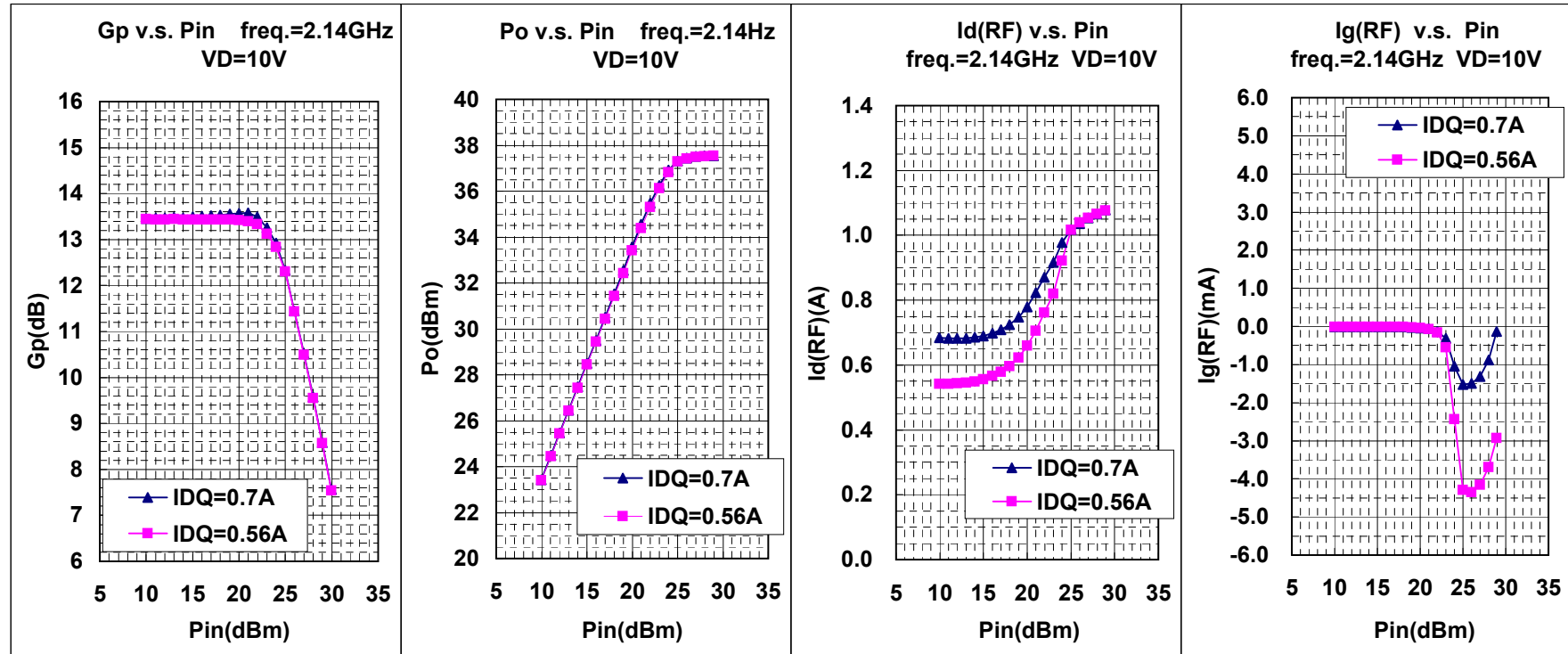
**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**



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**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**

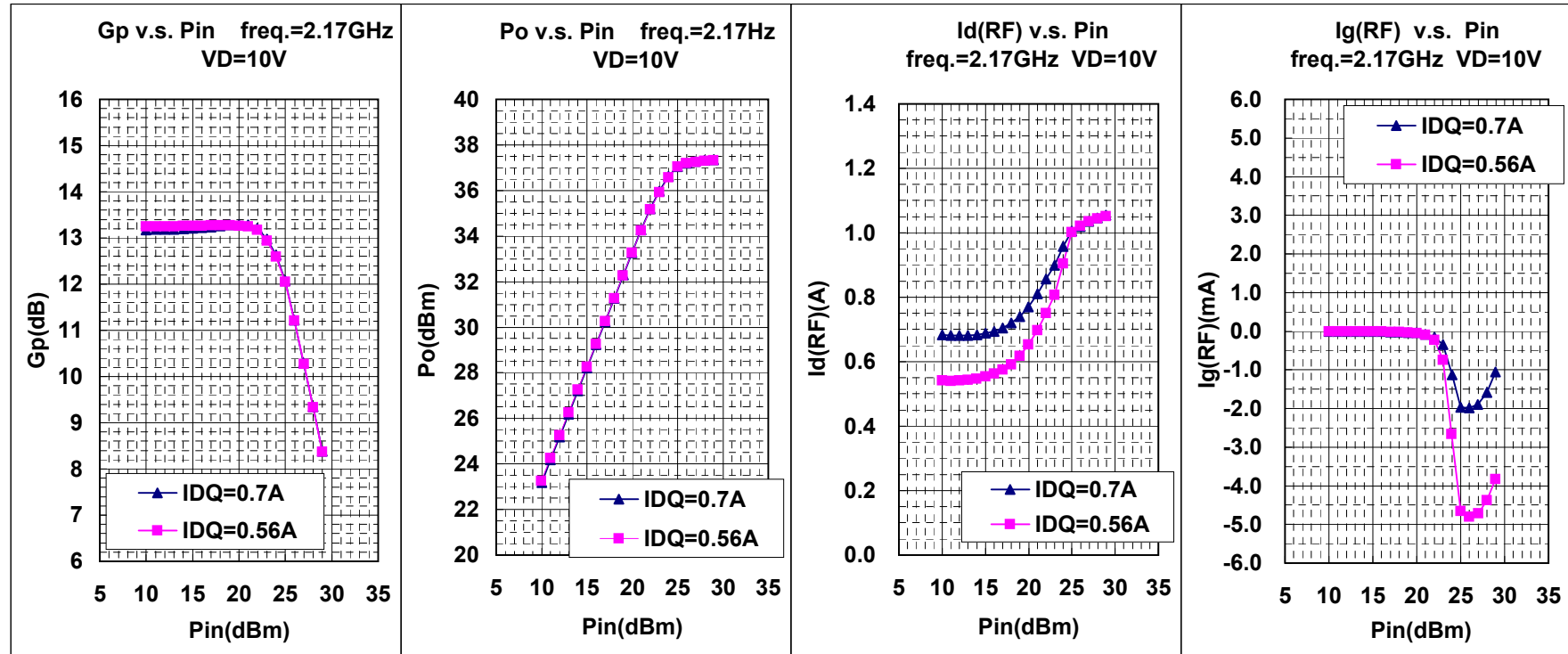
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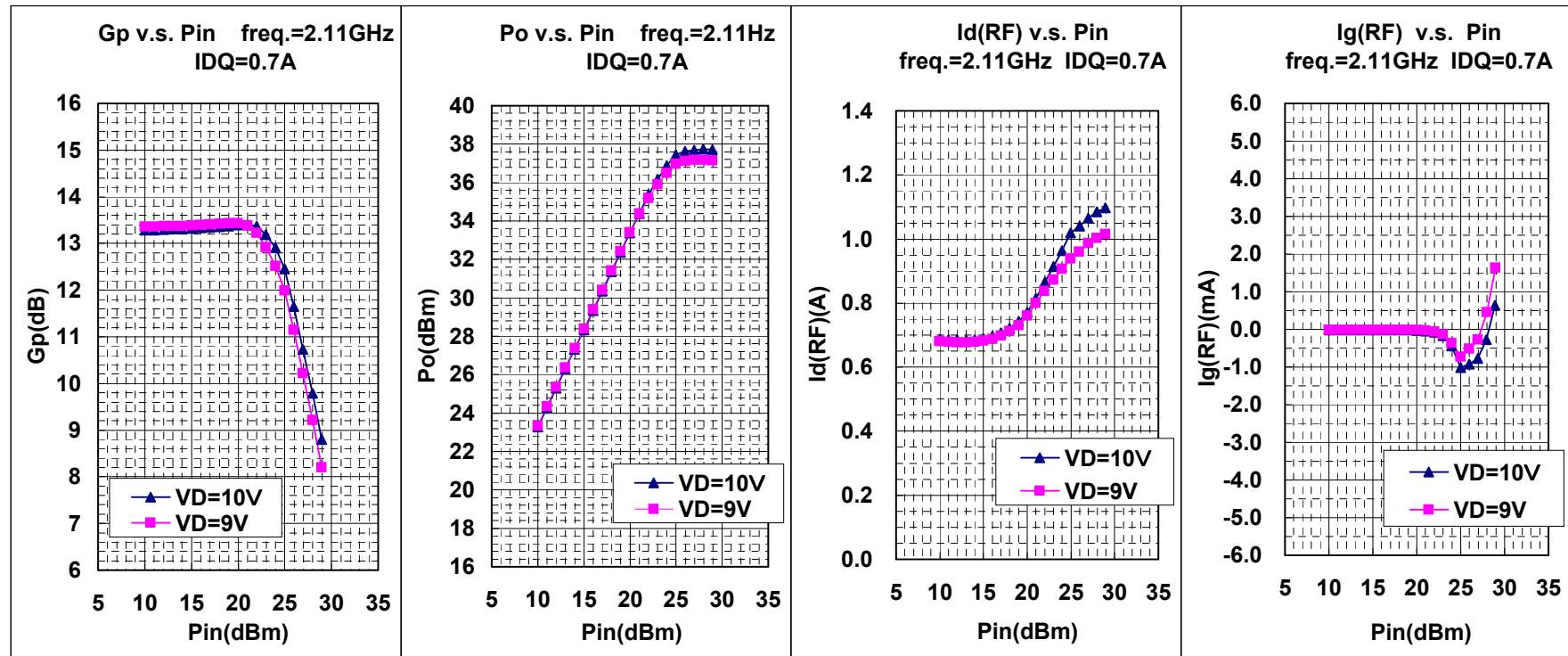
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**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**

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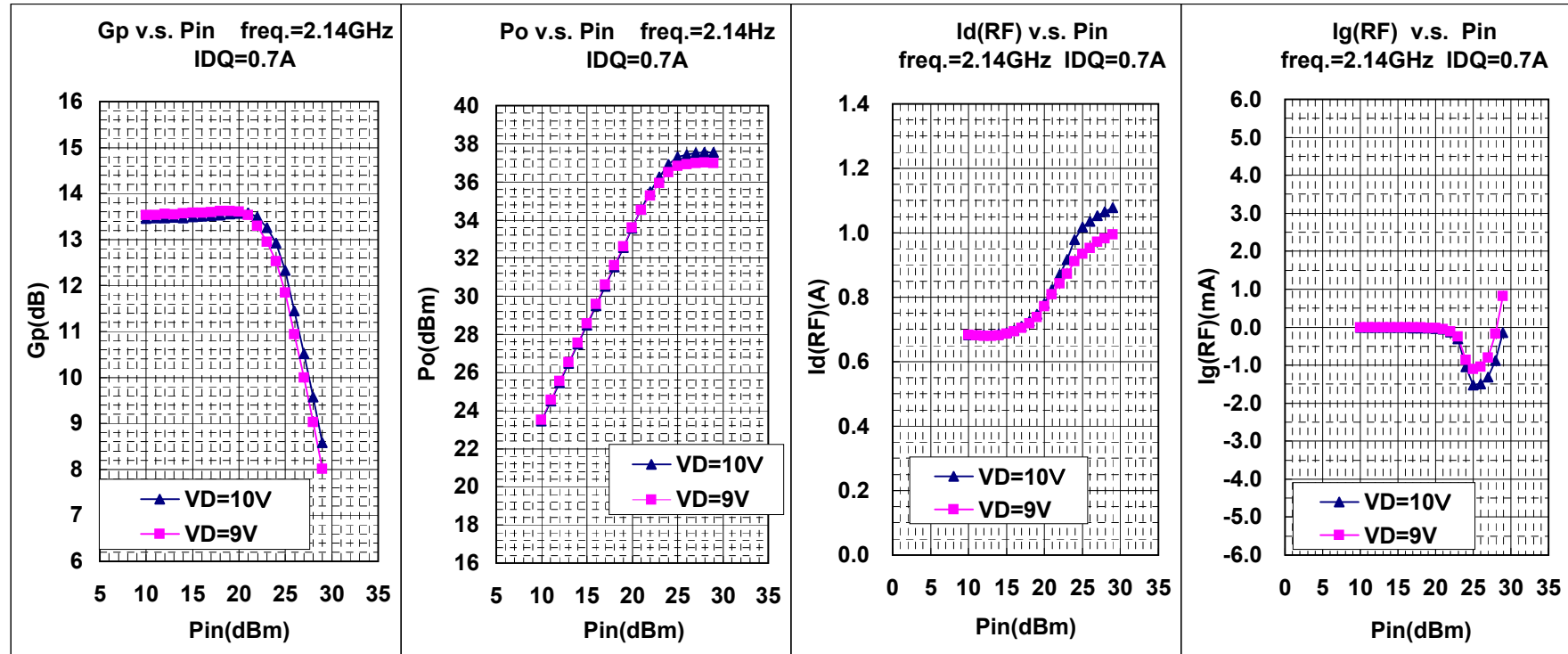
**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**



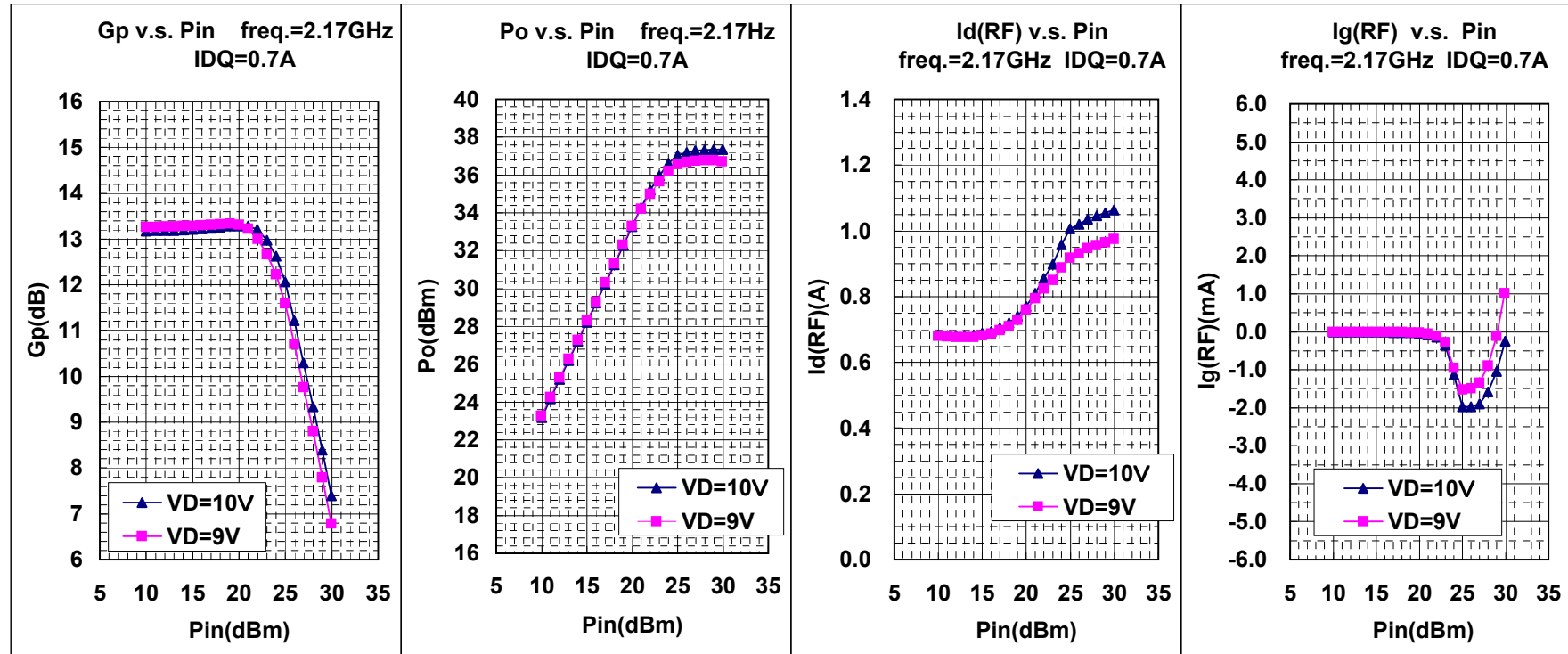
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**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**

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**MGF0952P RF TEST DATA(CW)**  
**Gp,Po,Id(RF),Ig(RF) v.s. Pin**

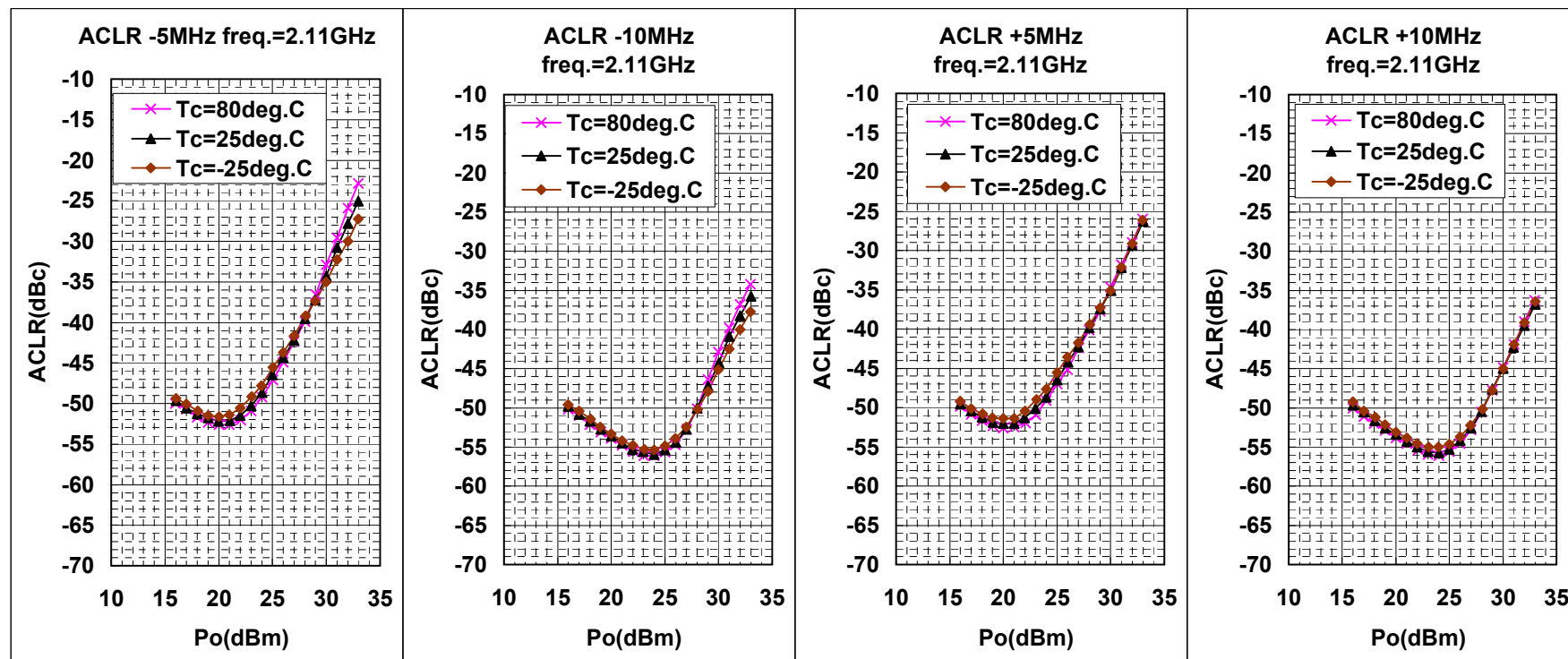




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MGF0952P RF TEST DATA(W-CDMA) VD=10V,IDQ=0.7A  
ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal

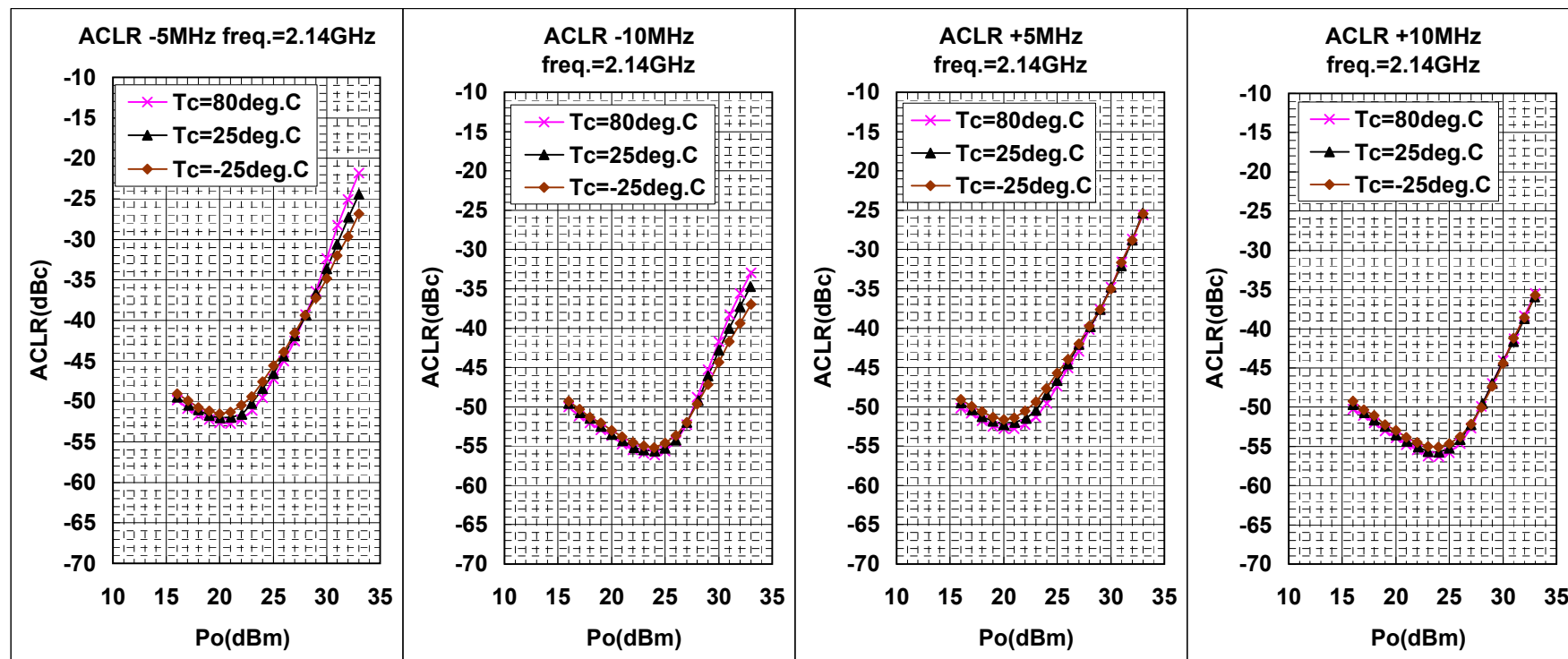
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MGF0952P RF TEST DATA(W-CDMA) VD=10V,IDQ=0.7A  
ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal

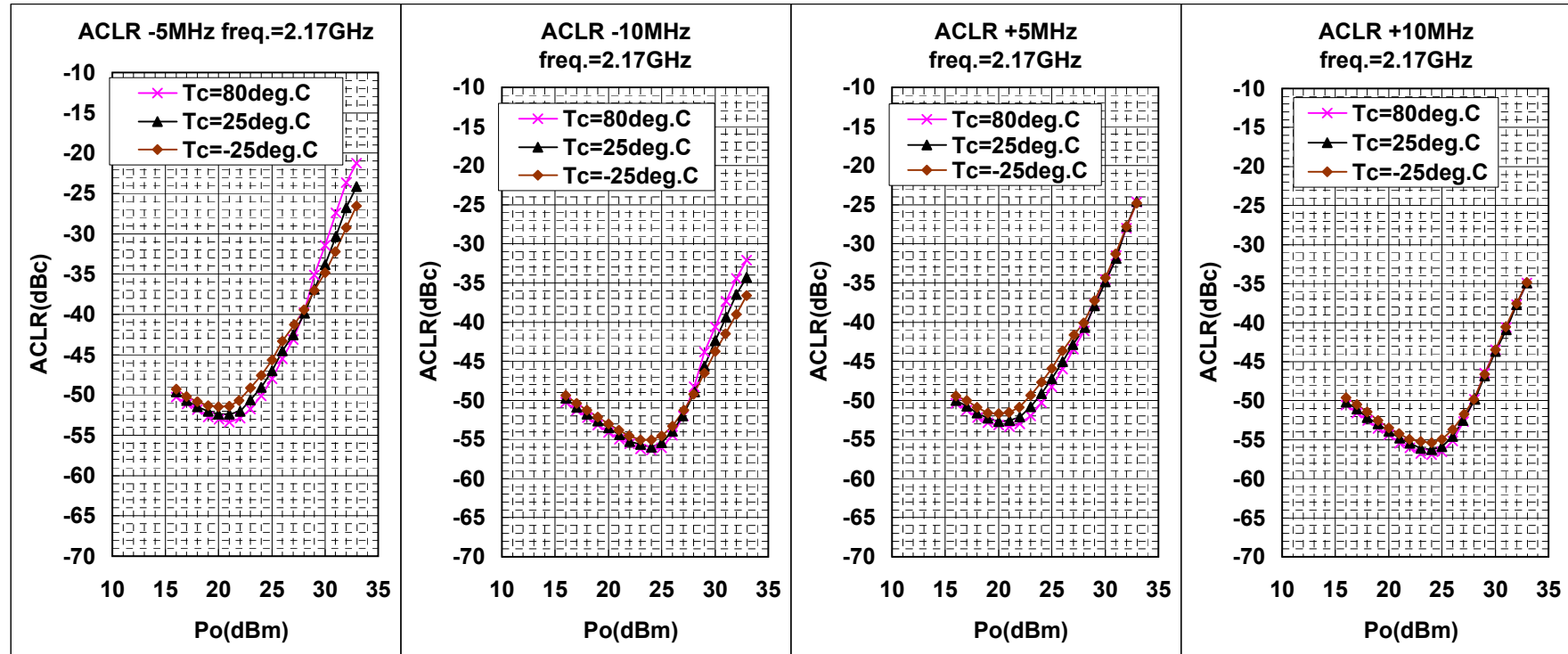
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MGF0952P RF TEST DATA(W-CDMA) VD=10V,IDQ=0.7A  
ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal

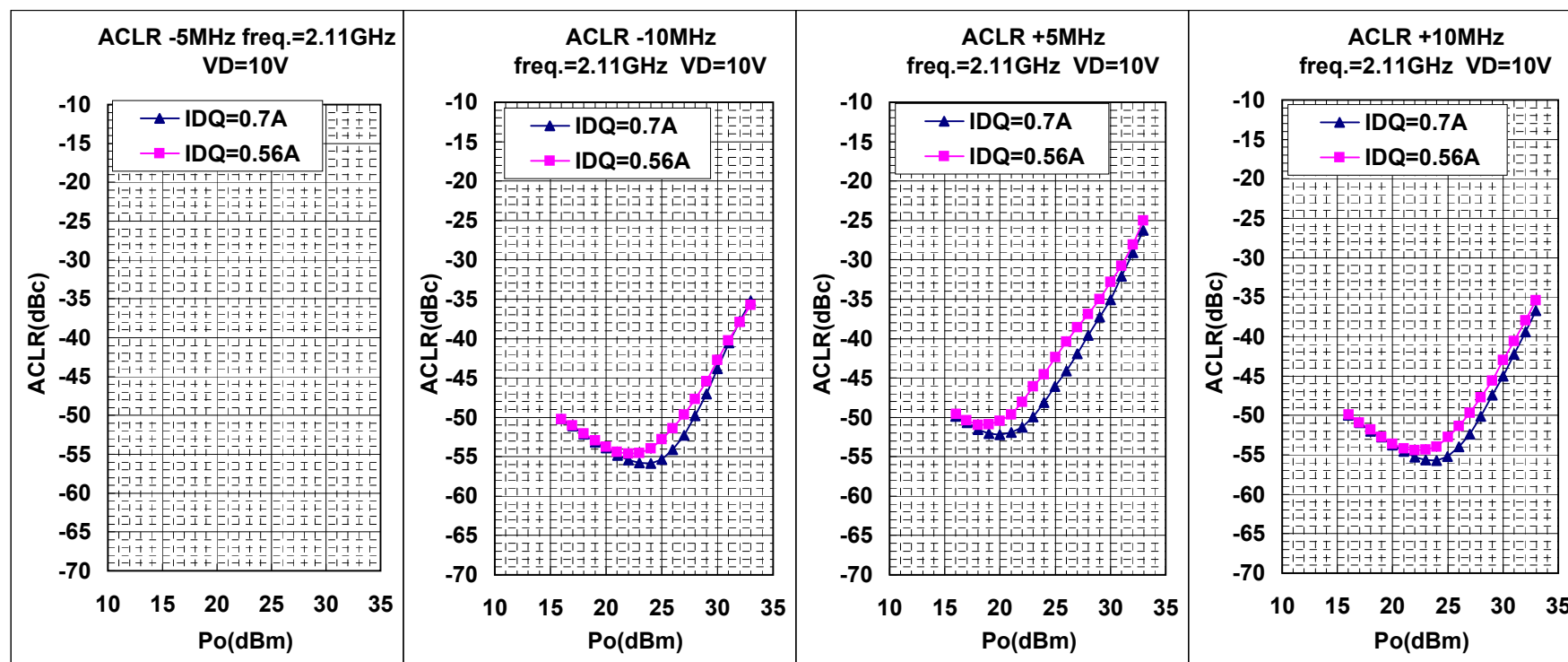
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal**

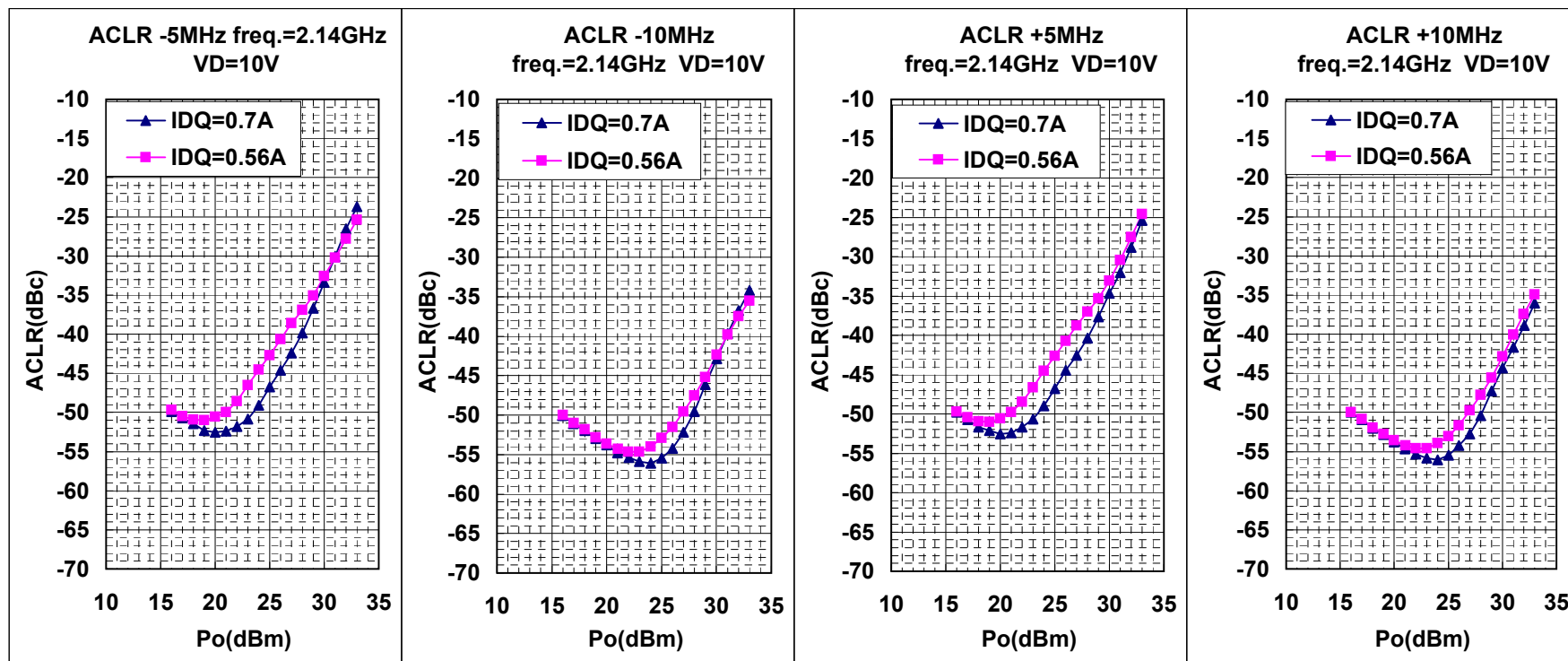
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal**

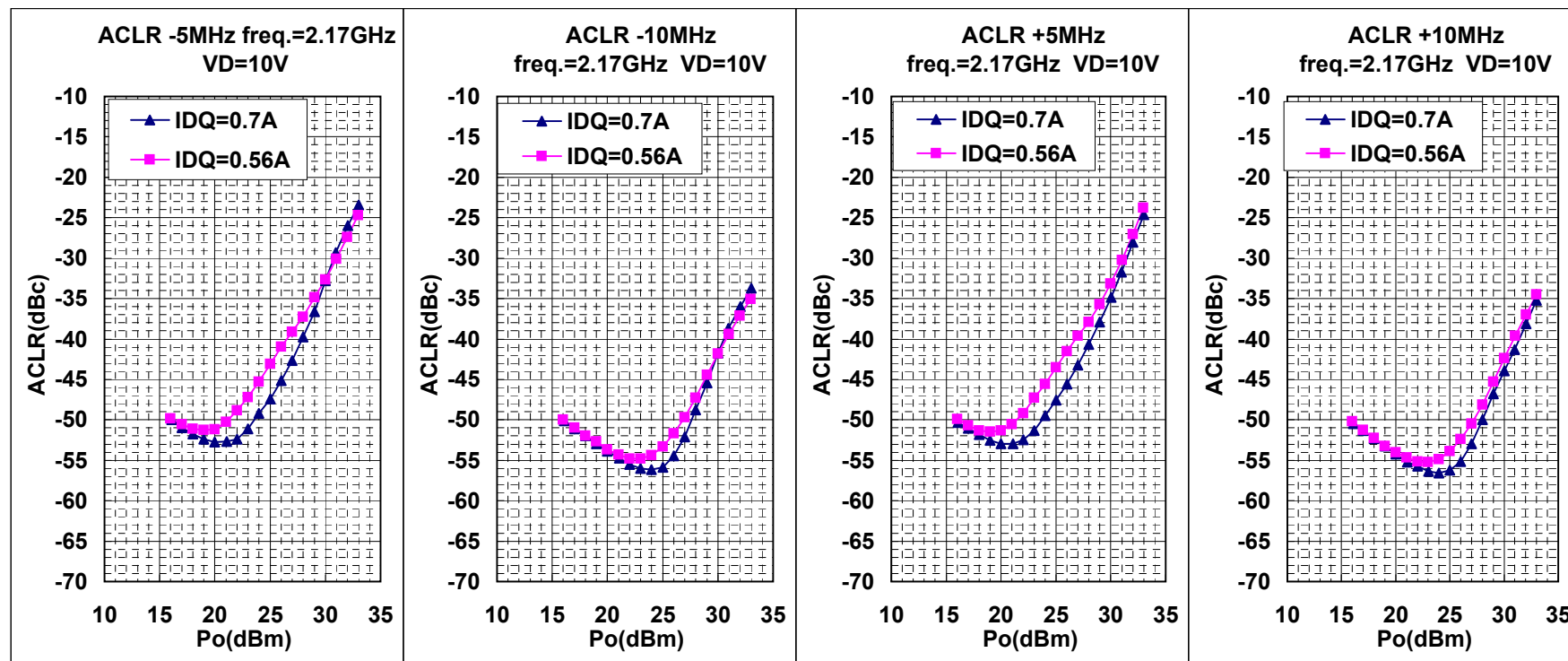
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal**

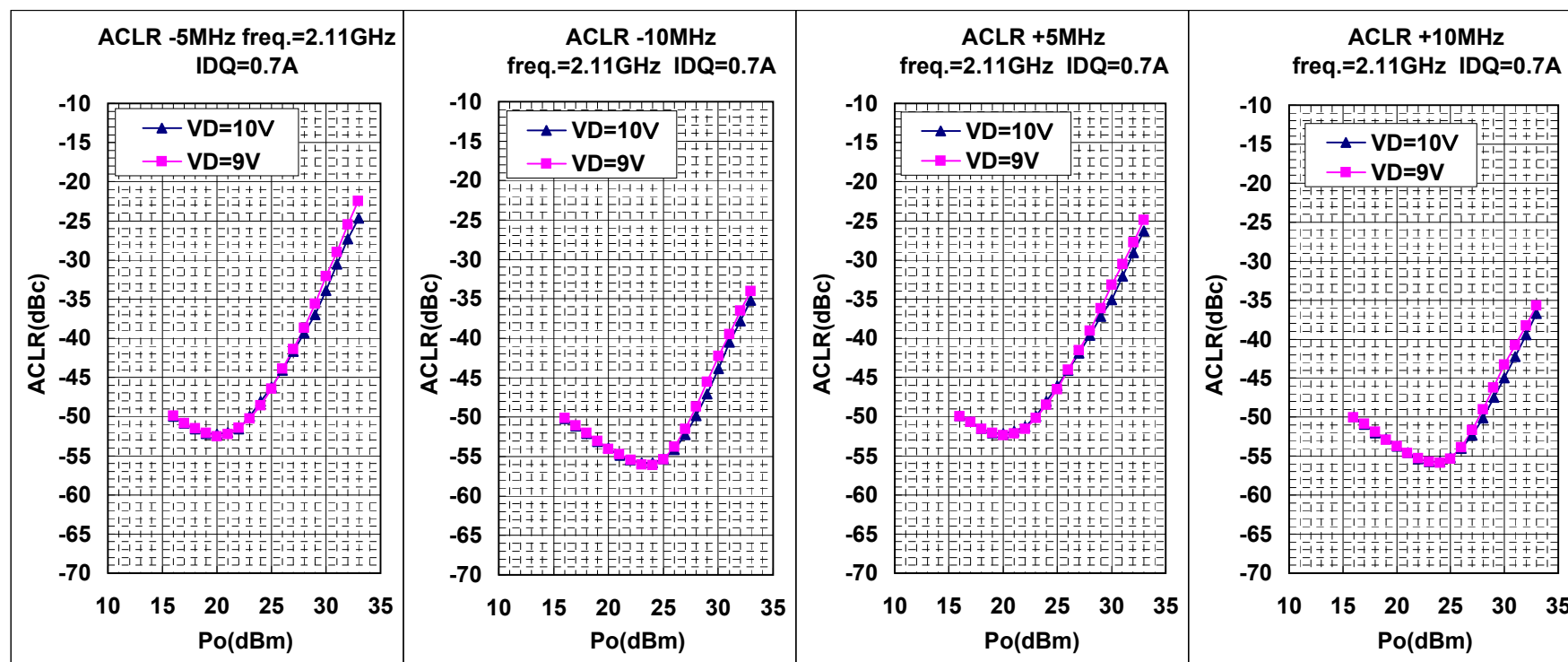
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal**

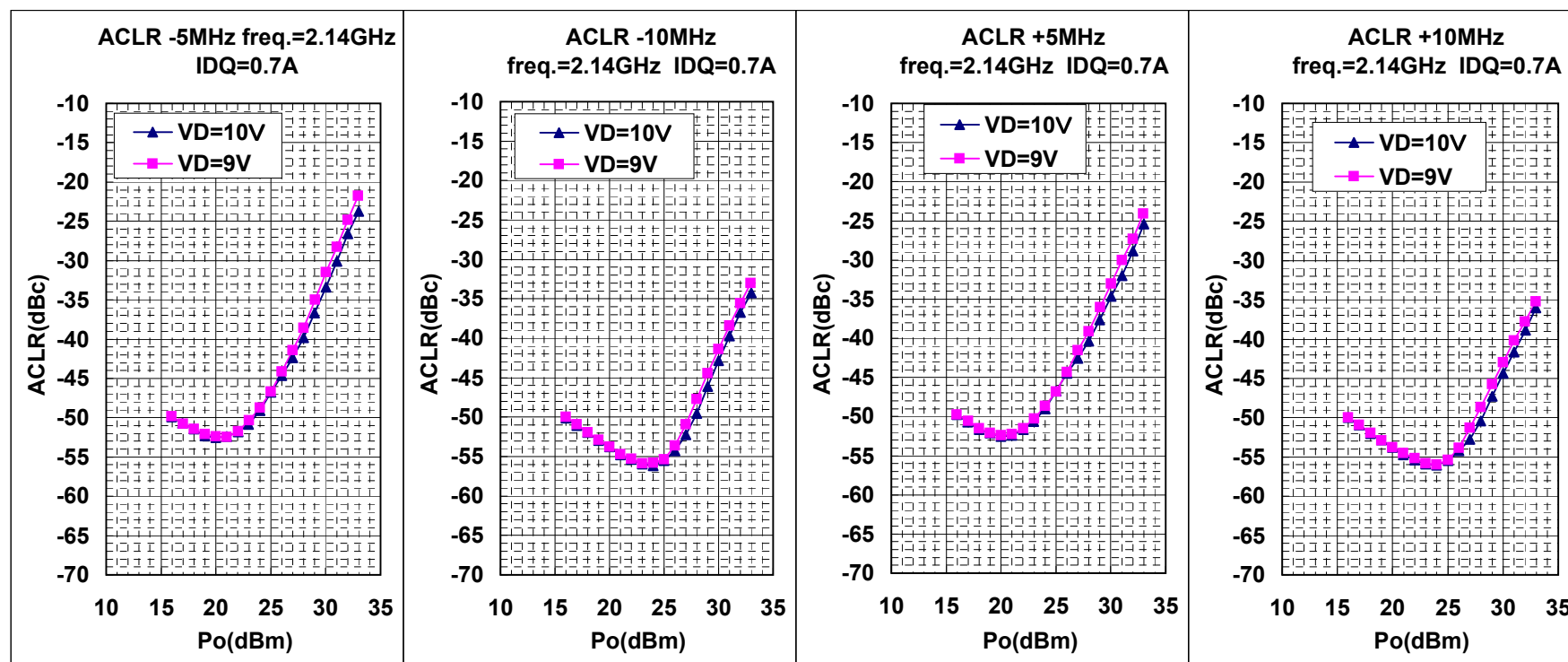
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal**

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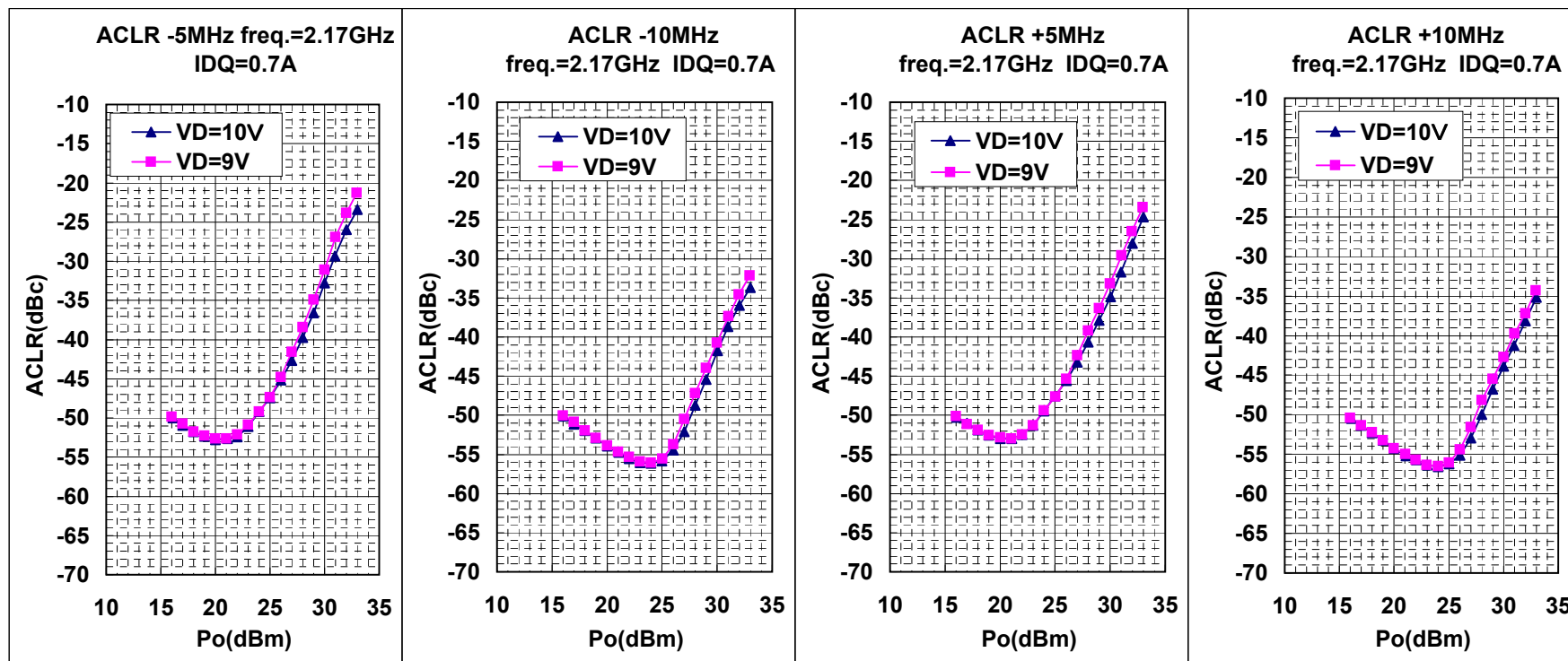




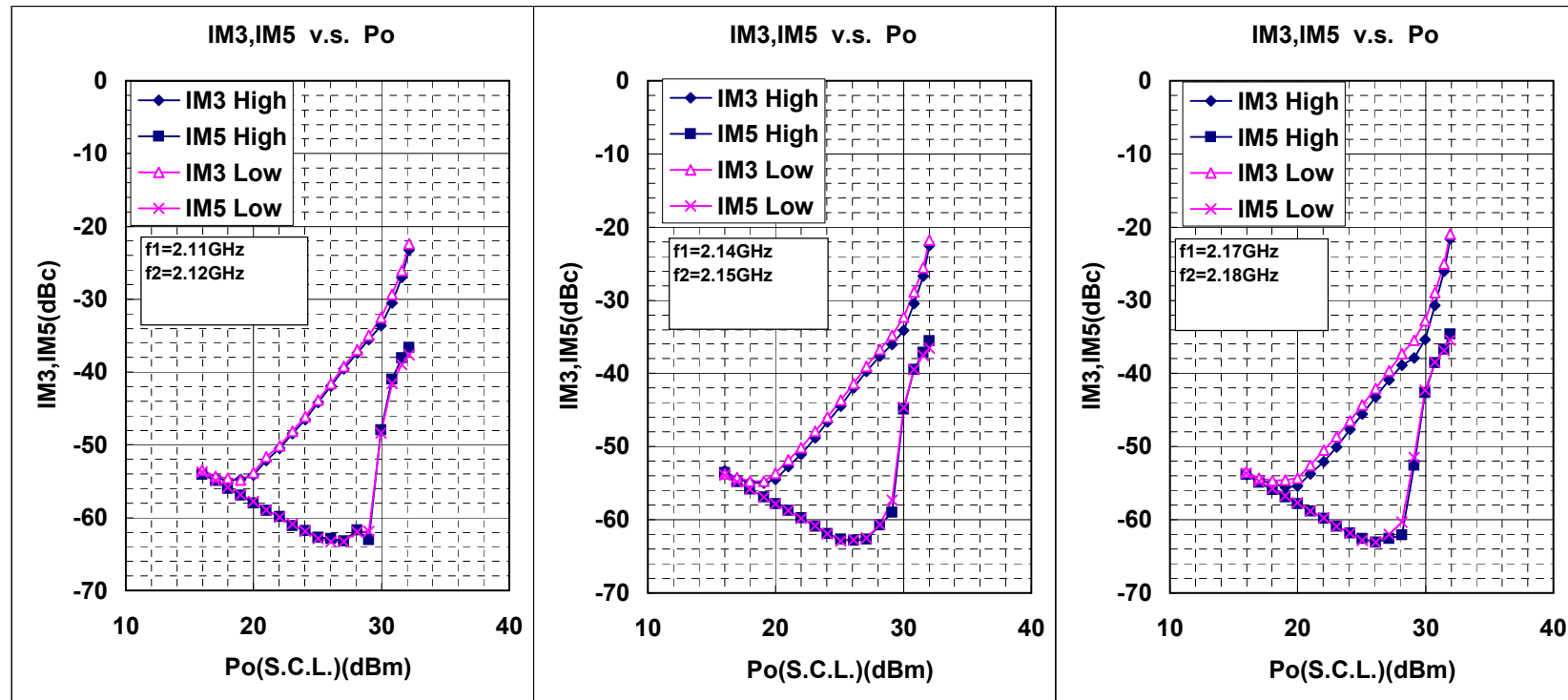
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**MGF0952P RF TEST DATA(W-CDMA)**  
**ACLR v.s. Po 3GPP TEST MODEL1 64ch's 2carrier Signal**

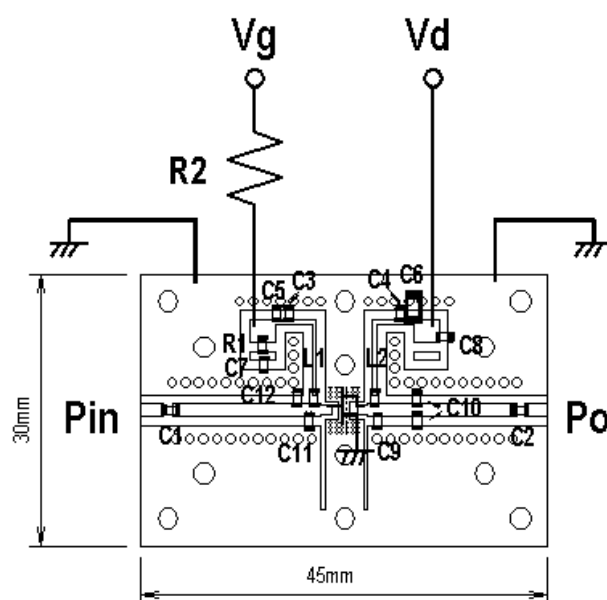
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MGF0952P RF TEST DATA VD=10V,Idq=0.7A  
IM3,IM5 v.s. Pin



# MGF0952P TEST FIXTURE $f=2.11\text{-}2.17\text{GHz}$



$C1, C2, C3, C4 = 20\text{pF}$   
 $C5, C7, C8 = 1000\text{pF}$   
 $C9 = 2\text{pF}$   
 $C11 = 3\text{pF}$   
 $C10 = 1\text{pF}$   
 $C12 = 0.5\text{pF}$   
 $C6 = 4.7\mu\text{F}$   
 $L1, L2 = 12\text{nH}$   
 $R1 = 51\text{ohm}$   
 $R2 = 100\text{ohm}$

Board material: FR4 Thickness=0.8(mm)  
 Specific dielectric constant=4.4

**L & S BAND GaAs FET [ Plastic Mold Lead-less PKG ]****Requests Regarding Safety Designs**

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